



EMC TEST REPORT For CE

Test Report No. : KES-E1-17T0828
Date of Issue : Dec. 15, 2017
Product name : NETWORK CAMERA
Model/Type No. : SNP-6320P
Variant Model : -
Applicant : Hanwha Techwin Co., Ltd.
Applicant Address : 1204, Changwon-daero, Seongsan-gu Changwon-si,
Gyeongsangnam-do, Korea
Manufacturer : Hanwha Techwin (Tianjin) Co.,Ltd.
Manufacturer Address : No.11 Weiliu Rd, Micro-Electronic Industrial Park, TEDA,
Tianjin, 300385, People's Republic of China
Date of Receipt : Dec. 08, 2017
Test date : Dec. 11, 2017 ~ Dec. 13, 2017
Test Results : ☒ **In Compliance** ☐ **Not in Compliance**

Tested by

Sung Min, Choi
EMC Test Engineer

Reviewed by

Dong-Hun, Jang
EMC Technical Manager

This test report is not related to KOLAS.

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REPORT REVISION HISTORY

Date	Test Report No.	Revision History
Dec. 15, 2017	KES-E1-17T0828	Issued

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1.0 General Product Description

Main Specifications of E.U.T are:

Video	
Imaging Device	1/2.8" Progressive Scan CMOS
Total Pixels	1952(H) x 1236(V), 2.41M
Effective Pixels	1944(H) x 1224(V), 2.38M
Scanning System	Progressive
Min. Illumination	Color : 0.3 Lux (1/30sec, F1.6, 50IRE) B/W : 0.03 Lux (1/30sec, F1.6, 50IRE)
S / N Ratio	50dB
Video Out	CVBS : 1.0 Vp-p / 75Ω composite, 720x480(N), 720x576(P), for installation
Lens	
Focal Length (Zoom Ratio)	4.44~142.6mm(Optical 32X)
Max. Aperture Ratio	1.6 (Wide) ~ 4.4 (Tele)
Angular Field of View	H : 62.8°(Wide) ~ 2.23°(Tele) / V : 36.80°(Wide) ~ 1.26°(Tele)
Min. Object Distance	Wide 10mm ,Tele 1.5m
Focus Control	Auto / Manual / One Push
Lens Type	DC Auto Iris
Mount Type	Board-in type
Pan/Tilt/Rotate	
Pan Range	360° Endless
Pan Speed	Preset : 700°/sec, Manual : 0.024°/sec ~120°/sec
Tilt Range	210°(-15° ~195°)
Tilt Speed	Preset : 700°/sec, Manual : 0.024°/sec ~120°/sec
Rotate Range	-
Preset	255ea
Preset Accuracy	±0.2°
Auto Tracking	Off / On , Schedule mode. Auto Tracking Mask mode.
Operational	
Camera Title	Off / On (Displayed up to 45 characters)
Day & Night	Auto (ICR) / Color / B/W / External / Schedule
Backlight Compensation	Off / BLC / HLC
Wide Dynamic Range	120dB
Contrast Enhancement	SSDR (Samsung Super Dynamic Range) (Off / On)
Digital Noise Reduction	SSNR III (2D+3D Noise Filter) (Off / On)
Digital Image Stabilization	Off / On
Defog	Auto/Manual/Off



1.1 Test Voltage & Frequency

Unless indicated otherwise on the individual data sheet or test results, the test voltage and frequency was as indicated below.

Voltage ☐ 230Vac ☐ 100 Vac ☒ 24 Vac ☐ 12 Vdc ☒ PoE
Frequency ☐ 50 Hz ☐ 60 Hz ☐ Hz

1.2 Variant Model Differences

Not applicable

1.3 Device Modifications

Not applicable

1.4 Equipment Under Test

Description	Model Number	Serial Number	Manufacturer	Remarks
NETWORK CAMERA	SNP-6320P	-	Hanwha Techwin (Tianjin) Co.,Ltd	E.U.T

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1.5 Support Equipments

Description	Model Number	Serial Number	Manufacturer	Remarks
PC NVR	XAR-1601H4	511NZGK001135	LG	-
Monitor	LS23C340	ZXPCHTMF A02346H	SAMSUNG	
Monitor Adaptor	PN3014	-	SAMSUNG	
Speaker	BR10000A CUVE	-	BEIJING EDIFIER HI-TECH GROUP.	-
MIC	CMK-303	-	CAMAC	-
AC Adartor	MKAC-96- 246000K	-	ShenZhen MaCable Technology Co.,Ltd Dongguan Branch	
POE Adaptor	POE 36U-1AT-R	P90215791A1	PHIHONG	
Controller	SPC-1010	C50E67WG10100F	SamSung Techwin Co.,Ltd.	
Controller Adaptor	RS-AB1000	-	Dongguan JinhuaSheng Power Technology Co.,Ltd.	
Alarm	SIP-1201DD D0	-	SAMSUNG TECHWIN CO., LTD.	-
Keyboard	K100	-	Logitech Inc.	-
Mouse	M-BZ96C		Microsoft	
USB 3.0 Memory	-	-	Sandisk	16G
USB 3.1 Memory	-	-	Sandisk	16G

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1.6 External I/O Cabling

■ AC 24 V Mode

Start		END		Cable Spec.	
Description	I/O Port	Description	I/O Port	Length	Shield
Network Camera (E.U.T)	RJ-45	Notebook	RJ-45	3.0	U
	3.5 mm	Speaker	3.5 mm	1.6	U
	3.5 mm	MIC	3.5 mm	1.7	U
	3 Pin	Alarm	3 Pin	4.0	U
	RS-485 (3 Pin)	Controller	RS-485 (3 Pin)	3.5	U
PC NVR	VGA	Monitor	VGA	1.2	U
	PS2	Keyboard	PS2	1.5	U
	USB 2.0	Mouse	USB 2.0	1.5	U
	USB 3.0	USB Memory	USB 3.0	-	-
	USB 3.1	USB Memory	USB 3.1	-	-

* Unshielded=U, Shielded=S

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■ PoE Mode

Start		END		Cable Spec.	
Description	I/O Port	Description	I/O Port	Length	Shield
Network Camera (E.U.T)	RJ-45 (PoE)	PoE Adaptor	RJ-45 (PoE)	5.0	U
	3.5 mm	Speaker	3.5 mm	1.6	U
	3.5 mm	MIC	3.5 mm	1.7	U
	RS-485(4Pin)	Controller	RS-485(2Pin)	3.0	U
	RS-4+5(2Pin)	Alarm	RS-485(2Pin)	3.0	U
PC NVR	RJ-45 (DATA)	PoE Adaptor	RJ-45 (DATA)	5.0	U
	VGA	Monitor	VGA	1.2	U
	PS2	Keyboard	PS2	1.5	U
	USB 2.0	Mouse	USB 2.0	1.5	U
	USB 3.0	USB Memory	USB 3.0	-	-
	USB 3.1	USB Memory	USB 3.1	-	-

* Unshielded=U, Shielded=S

1.7 E.U.T Operating Mode(s)

Test Mode	operating
AC 24 V	E.U.T Monitoring, Ping Test
PoE	

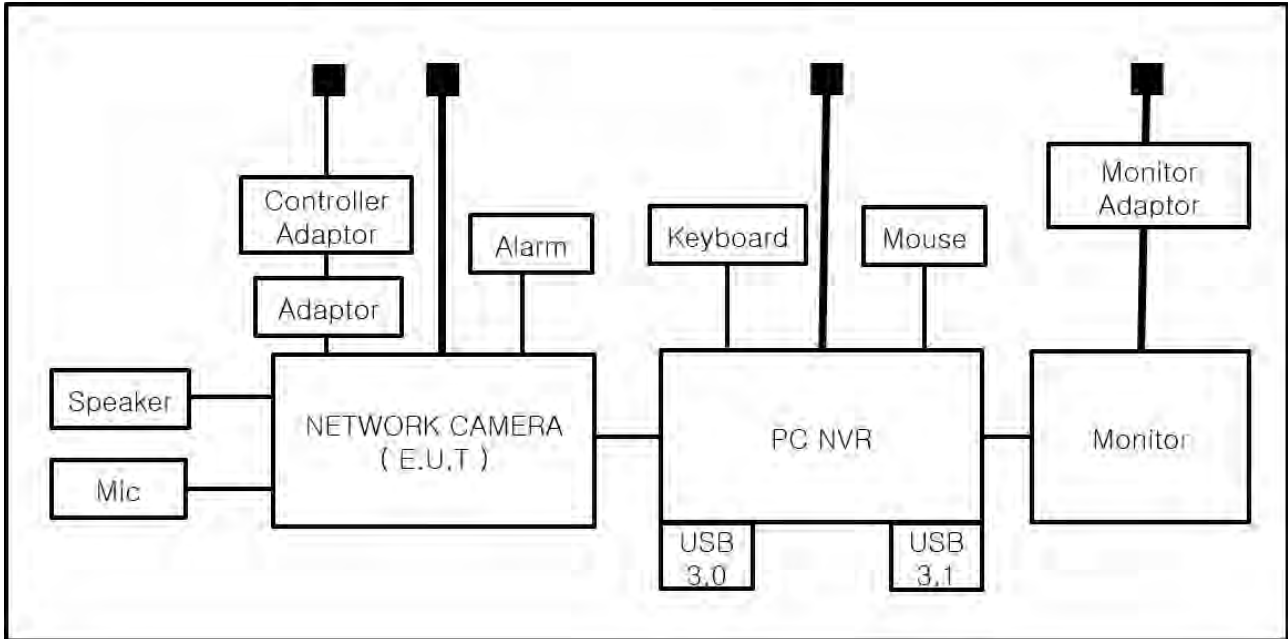
E.U.T Test operating S/W		
Name	Version	Manufacture Company
Webviewer	-	Hanwha Techwin Co., Ltd.

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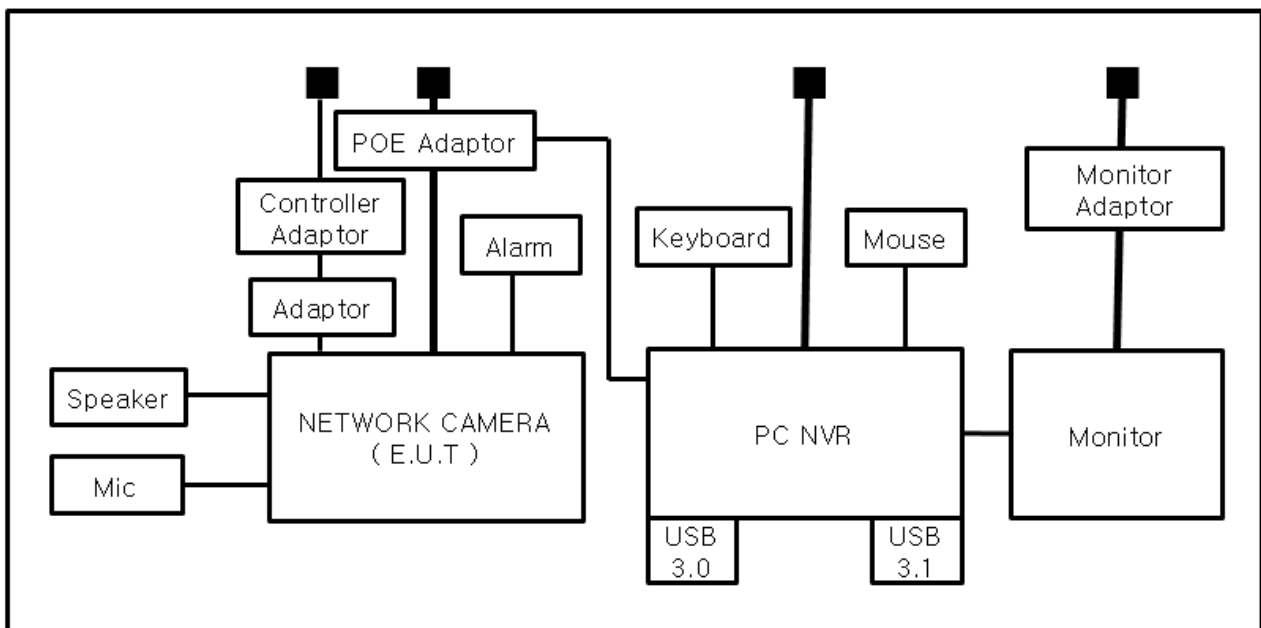
1.8 Configuration

■ AC Main
□ DC Main

■ AC 24 V Mode



■ PoE Mode



1.9 Remarks when standards applied

- N/A

1.10 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less.

1.11 Test Facility

The measurement facility is located at 473-21 Gayeo-ro, Yeosu-si, Gyeonggi-do, 12658, Korea. The sites are constructed in conformance with the requirements of ANSI C63.4 and CISPR Publication 32.

1.12 Laboratory Accreditations and Listings

Country	Agency	Scope of Accreditation	Logo
USA	FCC	3 & 10 meter Open Area Test Sites and one conducted site to perform FCC Part 15/18 measurements.	
JAPAN	VCCI	Mains Ports Conducted Interference Measurement, Telecommunication Ports Conducted Disturbance Measurement and Radiation 10 meter site, Facility for measuring radiated disturbance above 1 GHz	 R-4308, C-4798, T-2311, G-914
KOREA	MSIP	EMI (10 meter Open Area Test Site and two conducted sites) Radio(3 & 10 meter Open Area Test Sites and one conducted site) EMS (ESD, RS, EFT/Burst, Surge, CS, Magnetic, Dips and interruptions)	 KR0100
Canada	IC	3 & 10 meter Open Area Test Sites and one conducted site	 4769B-1
Europe	CE	EMI (10 meter Open Area Test Site and two conducted sites) Radio(3 & 10 meter Open Area Test Sites and one conducted site) EMS (ESD, RS, EFT/Burst, Surge, CS, Magnetic, Dips and interruptions)	
International	KOLAS	EMI (10 meter Open Area Test Site and two conducted sites) Radio(3 & 10 meter Open Area Test Sites and one conducted site) EMS (ESD, RS, EFT/Burst, Surge, CS, Magnetic, Dips and interruptions)	

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2.0 Test Regulations

The emissions tests were performed according to following regulations:

☒ **EMC – Directive 2014/30/EU**

☐ EN 61000-6-3:2011

☐ EN 61000-6-1:2007

☐ EN 61000-6-4:2007 +A1:2011

☐ EN 61000-6-2:2005

☐ EN 55011:2007 +A1:2010

☐ Group 1
☐ Class A

☐ Group 2
☐ Class B

☐ EN 55014-1:2006 +A2:2011

☐ EN 55014-2:1997 +A2:2008

☐ EN 55015:2013

☐ EN 61547:2009

☒ EN 55032:2012/AC:2013

☒ Class A

☐ Class B

☐ EN 55024:2010 +A1:2015

☒ EN 50130-4:2011

☐ EN 61000-3-2:2014

☐ EN 61000-3-3:2013

☐ EN 61326-1:2013



-
- | | | |
|---|----------------------------------|----------------------------------|
| ☐ VCCI V-3 / 2015.04 | ☐ Class A | ☐ Class B |
| ☐ AS/NZS CISPR22:2009 +A1:2010 | ☐ Class A | ☐ Class B |
| ☐ 47 CFR Part 15, Subpart B | | |
| ☐ CISPR 22:2009 +A1:2010 | ☐ Class A | ☐ Class B |
| ☐ ANSI C63.4-2009 | | |
| ☐ IC Regulation ICES-003 : 2016 | | |
| ☐ CAN/CSA CISPR 22-10 | ☐ Class A | ☐ Class B |
| ☐ ANSI C63.4-2014 | | |
|
☐ RE- Directive 2014/53/EU | | |
|
☐ EN 301 489-1 V1.9.2 | | |
| ☐ Equipment for fixed use | | |
| ☐ Equipment for vehicular use | | |
| ☐ Equipment for portable use | | |
|
☐ EN 301 489-3 V1.6.1 | | |
|
☐ EN 301 489-17 V2.2.1 | | |
|
☐ EN 60945:2002 | | |



2.1 Conducted Emissions at Mains Power Ports

Test Date

Dec. 12, 2017

Test Location

Electro wave Shieldroom

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMI Test S/W	EMC32	R & S	9.12.00	-
☒	EMI TEST RECEIVER	ESR3	R & S	101781	04, 27, 2018
☒	LISN	ENV216	R & S	101787	01, 11, 2018
☒	LISN	ESH2-Z5	R & S	100450	04, 27, 2018
☒	PULSE LIMITER	ESH3-Z2	R & S	101915	11, 27, 2018
☐	LISN	NNBM8124	SCHWARZBECK	8124-1002	08, 07, 2018
☐	LISN	NNBM8124	SCHWARZBECK	8124-1003	08, 07, 2018

Test Conditions

Temperature: 20,1 °C
Relative Humidity: 42,1 % R.H.

Frequency Range of Measurement

150 kHz to 30 MHz

Instrument Settings

IF Band Width: 9 kHz

Test Results

The requirements are:

- ☒ PASS
☐ NOT PASS
☐ NOT APPLICABLE

Remarks

See Appendix A for test data.

2.2 Conducted Emissions at Telecommunication Ports

Test Date

Dec. 12, 2017

Test Location

Electro wave Shieldroom

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMI Test S/W	EMC32	R & S	9.12.00	-
☒	EMI TEST RECEIVER	ESR3	R & S	101781	04, 27, 2018
☒	LISN	ENV216	R & S	101787	01, 11, 2018
☒	LISN	ESH2-Z5	R & S	100450	04, 27, 2018
☒	PULSE LIMITER	ESH3-Z2	R & S	101915	11, 27, 2018
☒	8-WIRE ISN CAT3,5	ENY81	R & S	100174	01, 11, 2018
☐	8-WIRE ISN CAT6	ENY81-CAT6	R & S	101665	01, 11, 2018
☐	ISN	ISN S8	SCHWARZBECK	ISN-S8-0019	05, 12, 2018
☐	CDN	CDNS502A	TESEQ	40431	01, 11, 2018

Test Conditions

Temperature: 20,1 °C
Relative Humidity: 42,1 % R.H.

Frequency Range of Measurement

150 kHz to 30 MHz

Instrument Settings

IF Band Width: 9 kHz

Test Results

The requirements are:

- ☒ PASS
☐ NOT PASS
☐ NOT APPLICABLE

Remarks

See Appendix A for test data.

2.3 Radiated Electric Field Emissions(Below 1 GHz)

Test Date

Dec. 11, 2017

Test Location☐ OPEN AREA TEST SITE #2 ☒ SEMI ANECHOIC CHAMBER #4(10m)**Test Equipment**

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMI Test S/W	EP5/RE	TOYO Corporation	6.0.0	-
☒	EMI TEST RECEIVER	ESU26	R & S	100551	04, 18, 2018
☒	AMPLIFIER	SCU 01	R & S	100603	11, 27, 2018
☒	TRILOG-BROADBAND ANTENNA	VULB9163	Schwarzbeck	716	11, 28, 2018

Test ConditionsTemperature: 22,3 °C
Relative Humidity: 41,9 % R.H.**Frequency Range of Measurement**

30 MHz to 1 GHz

Instrument Settings

IF Band Width: 120 kHz

Test Results

The requirements are:

- ☒ PASS
☐ NOT PASS
☐ NOT APPLICABLE

RemarksSee Appendix A for test data.

2.4 Radiated Electric Field Emissions(Above 1 GHz)

Test Date

Dec. 11, 2017

Test Location

SEMI ANECHOIC CHAMBER #3

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMI Test S/W	EP5/RE	TOYO Corporation	6.0.0	-
☒	EMI TEST RECEIVER	ESR7	R & S	101190	08, 07, 2018
☒	PREAMPLIFIER	8449B	AGILENT	3008A01967	05, 31, 2018
☐	ATTENUATOR	8491A	HP	32173	03, 24, 2018
☒	DOUBLE RIDGED HORN ANTENNA	SAS-571	A.H.SYSTEM,INC	781	05, 02, 2019

Test Conditions

Temperature: 22,0 °C
Relative Humidity: 41,6 % R.H.

Frequency Range of Measurement

1 GHz to 6 GHz

Instrument Settings

IF Band Width: 1 MHz

Test Results

The requirements are:

- ☒ PASS
☐ NOT PASS
☐ NOT APPLICABLE

Remarks

See Appendix A for test data.



2.5 Harmonic Current Emissions

Test Date

N/A

Test Location

Electro wave Shieldroom

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☐	EMI Test S/W	dpa.control	EM TEST	5.4.11.0	-
☐	DIGITAL POWER ANALYZER	DPA 500N	EM TEST	V1024106759	08, 09, 2018
☐	POWER SOURCE	ACS 500N6	EM TEST	V1024106760	-

Test Conditions

Relative Humidity: °C
 % R.H.

Classification of Equipment for Harmonic Current Emissions

- ☐ Class A
- ☐ Class B
- ☐ Class C(Below 25 W)
- ☐ Class C(Above 25 W)
- ☐ Class D

Test Results

The requirements are:

- ☐ PASS
- ☐ NOT PASS
- ☒ NOT APPLICABLE

Remarks

N/A : Because the E.U.T power is less than 75 W, limits are not specified.



2.6 Voltage Fluctuations and Flicker

Test Date

N/A

Test Location

Electro wave Shieldroom

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☐	EMI Test S/W	dpa.control	EM TEST	5.4.11.0	-
☐	DIGITAL POWER ANALYZER	DPA 500N	EM TEST	V1024106759	08, 08, 2018
☐	POWER SOURCE	ACS 500N6	EM TEST	V1024106760	-

Test Conditions

Relative Humidity: °C
 % R.H.

Test Results

The requirements are:

- ☐ PASS
☐ NOT PASS
☒ NOT APPLICABLE

Remarks

N/A : Because the E.U.T power is 24 V (ac) power and PoE Power, limits are not specified.

3.0 Criteria for compliance

Criteria for compliance was based on the following guidelines:

EN 50130-4:2011 Alarm systems-Part 4: Electromagnetic compatibility Product family standard: Immunity requirements for components of fire, intruder and social alarm systems

The variety and the diversity of the apparatus within the scope of this document makes it

difficult to define precise criteria for the evaluation of the immunity test results.

If as a result of the application of the tests defined in this standard, the apparatus becomes dangerous or unsafe then the apparatus shall be deemed to have failed the test.

A functional description and a definition of performance by the manufacture and noted in the test

report, based on the following criteria:

Electrostatic discharge

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of discharge is permissible, providing that is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

Radiated electromagnetic fields

There shall be no damage, malfunction or change of status due to the conditioning.

Flickering of an indicator during the application of discharge is permissible, providing which could be interpreted by associated equipment as a change, and no such

Flickering of indicators occurs at a field strength of 3 V/m.

For components of CCTV systems, where the picture is allowed at 10 V/m, providing.

(a) there is no permanent damage or change to EUT

(e.g. no corruption of memory or changes to programmable setting etc.)

(b) at 3 V/m, any deterioration of the picture is so minor that the system could still be used; and

(c) there is no observable deterioration of the picture at 1 V/m.

Fast transient burst / slow high energy voltage surge

There shall be no damage, malfunction or change of status due to the conditioning.
Flickering of an indicator during the application of discharge is permissible, providing
That there is no residual is permissible, providing that there is no residual change in the EUT or
any
change in outputs, which could be interpreted by associated equipment as a change.

Conducted RF immunity

There shall be no damage, malfunction or change of status due to the conditioning.
Flickering of an indicator during the application of discharge is permissible, providing
That there is no residual is permissible, providing that there is no residual change in the EUT or
any
change in outputs, which could be interpreted by associated equipment as a change,
and no such flickering of indicators oeuvres at $U = 130 \text{ dB}\mu\text{V}$.
For component of CCTV systems, where the status is monitored by observing the TV picture,
then deterioration of the picture is allowed at $U = 140 \text{ dB}\mu\text{V}$, providing:
(a) there is no permanent damage or change to the EUT
(e.g. no corruption of memory or changes to programmable settings etc.)
(b) at $U = 130 \text{ dB}\mu\text{V}$, any deterioration of the picture is so minor that the system could
still be used; and
(c) there in no observable deterioration of the picture at $U = 120 \text{ dB}\mu\text{V}$.

Voltage dip/interruption / Voltage variation

There shall be no damage, malfunction or change of status due to the conditioning.
Flickering of an indicator during the conditioning is permissible, providing that there is no
residual
change in the EUT or any change in outputs, which could be interpreted by associated
equipment
as a change. The EUT shall meet the acceptance criteria for the functional test, after the
conditioning.



3.1 Electrostatic Discharge

Reference Standard

EN 61000-4-2:2009

Test Date

Dec. 12, 2017

Test Location

EMS-ESD: Electro wave Shieldroom

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	ESD SIMULATOR	ESS-2000	Noise Ken	ESS05X4620	02, 24, 2018
☒	HCP	-	Noise Ken	-	-
☒	VCP	-	Noise Ken	-	-

Test Conditions

Temperature: 19,9 °C
Relative Humidity: 48,0 % R.H.
Atmospheric Pressure: 101,6 kPa



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Test Specifications

Discharge Factor: ≥ 1 s

Discharge Impedance: 330 ohm / 150 pF

Kind of Discharge: Air, Contact (direct and indirect)

Polarity: Positive and Negative

Number of Discharge: 10 at all locations for Air discharge
10 at all locations for Contact discharge

Discharge Voltage:	Contact	Air	HCP	VCP
	☐ 2 kV	☒ 2 kV	☐ 2 kV	☐ 2 kV
	☐ 4 kV	☒ 4 kV	☐ 4 kV	☐ 4 kV
	☒ 6 kV	☐ 6 kV	☒ 6 kV	☒ 6 kV
	☐ 8 kV	☒ 8 kV	☐ 8 kV	☐ 8 kV
	☐ 15 kV	☐ 15 kV	☐ 15 kV	☐ 15 kV

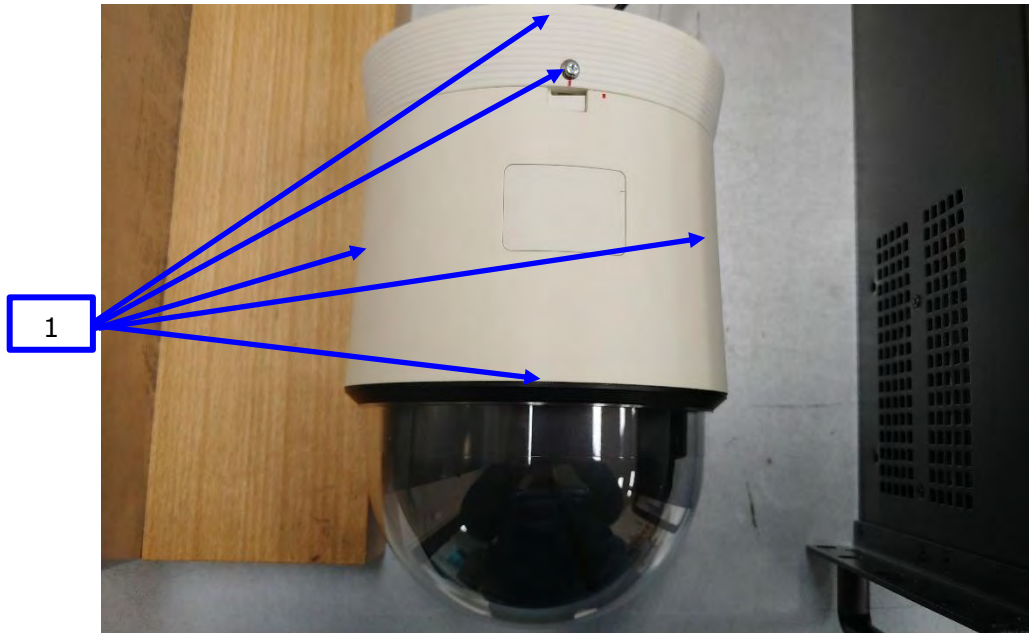
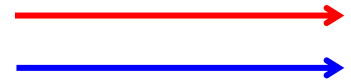
Notes: HCP: Horizontal coupling plane

VCP: Vertical coupling plane

Required Performance Criteria: ☒ Complied

Location of Discharge:

Air
Contact



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Test report No.:
KES-E1-17T0828
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Test Data**■ AC 24 V****Indirect Discharge**

No.	Test Point	Discharge Method	Observations	Remarks
1	HCP Contact	Contact Discharge	Complied	-
2	VCP Contact	Contact Discharge	Complied	-

Direct Discharge

No.	Test Point	Discharge Method	Observations	Remarks
1	Enclosure, Screw	Contact Discharge	Complied	-

■ PoE Mode**Indirect Discharge**

No.	Test Point	Discharge Method	Observations	Remarks
1	HCP Contact	Contact Discharge	Complied	-
2	VCP Contact	Contact Discharge	Complied	-

Direct Discharge

No.	Test Point	Discharge Method	Observations	Remarks
1	Enclosure, Screw	Contact Discharge	Complied	-

Note: "Blank" = Not performed

Observations:

Complied – No degradation of function

Test Results

- ☒ PASS Required Performance Criteria
☐ NOT PASS Required Performance Criteria

Remarks

PASS Required Performance Criteria.

3.2 Radiated Electric Field Immunity

Reference Standard

EN 61000-4-3:2006 +A2:2010

Test Date

Dec. 12, 2017

Test Location

EMS-RS: ☐ SEMI ANECHOIC CHAMBER #2 ☒ SEMI ANECHOIC CHAMBER #3

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMS Test S/W	EMC32	R & S	10.10.02	-
☒	SIGNAL GENERATOR	SMB 100A	R & S	177586	08, 07, 2018
☒	BROADBAND AMPLIFIER	BBA100	R & S	101239	08, 07, 2018
☒	BROADBAND AMPLIFIER	100S1G6M1	AR	579931	08, 07, 2018
☒	POWER METER	NRP2	R & S	103475	08, 07, 2018
☒	AVG POWER SENSOR	NRP-Z91	R & S	102526	08, 07, 2018
☒	AVG POWER SENSOR	NRP-Z91	R & S	102527	08, 07, 2018
☒	STACKED DOUBLE LOG-PER- ANTENNA	STPL9128 E	Schwarzbeck	9128ES-121	-
☒	DIRECTIONAL COUPLER	KYDC-D1070-DX40	KY TELECOM	KY150001	08, 07, 2018
☒	DOUBLE RIDGED HORN ANTENNA	SAS-571	A.H.SYSTEM, INC	781	05, 02, 2019

Test Conditions

Temperature: 20,7 °C
Relative Humidity: 42,6 % R.H.
Atmospheric Pressure: 100,2 kPa



Test Specifications

Antenna Polarization: Horizontal & vertical unless indicated otherwise

Antenna Distance: ☒ 3 m

Field Strength: ☐ 1 V/m ☐ 3 V/m
☒ 10 V/m

Frequency Range: ☐ 80 MHz to 1 GHz ☐ 1,4 GHz to 2,7 GHz
☒ 80 MHz to 2,7 GHz

Modulation: ☒ AM, 80 %, 1 kHz sine wave
☒ PM, 1 Hz (0,5 s ON : 0,5 s OFF)

Frequency step: ☒ 1 % step

Dwell Time: ☒ 1 s ☐ 3 s

of Sides Radiated: ☒ 4

Required Performance Criteria: ☒ Complied

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Test Data**■ AC 24 V Mode**

Side Exposed	Observations	
	Horizontal	Vertical
Front	Complied	Complied
Right	Complied	Complied
Back	Complied	Complied
Left	Complied	Complied

■ PoE Mode

Side Exposed	Observations	
	Horizontal	Vertical
Front	Complied	Complied
Right	Complied	Complied
Back	Complied	Complied
Left	Complied	Complied

Note: "Blank" = Not performed

Observations:

Complied – No degradation of function

Test Results

- ☒ PASS Required Performance Criteria
☐ NOT PASS Required Performance Criteria

Remarks

PASS Required Performance Criteria.

3.3 Electrical Fast Transients/Bursts

Reference Standard

EN 61000-4-4:2012

Test Date

Dec. 13, 2017

Test Location

EMS-EFT: Electro wave Shieldroom

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMS Test S/W	iec.control	AMETEK CTS	7.1.2	-
☒	ULTRA COMPACT SIMULATOR	UCS 500 N5	EM TEST	V0936105120	06, 26, 2018
☒	MOTOR VARIAC	MV2616	EM TEST	V0936105123	06, 26, 2018
☒	CAPACITIVE COUPLING CLAMP	HFK	EM TEST	070925	06, 26, 2018

Test Conditions

Temperature: 21,9 °C
Relative Humidity: 46,2 % R.H.
Atmospheric Pressure: 100,9 kPa

Test Specifications

Pulse Amplitude & Polarity: (AC Power Lines)	☐ ± 1.0 kV ☐ ± 4.0 kV	☒ ± 2.0 kV
Pulse Amplitude & Polarity: (Other supply / Signal Lines)	☐ ± 0.5 kV ☐ ± 2.0 kV	☒ ± 1.0 kV
Burst Period:	☒ 300 ms	☐ 2 s
Repetition Rate:	☐ 5 kHz	☒ 100 kHz
Duration of Test Voltage:	☒ ≥ 1 min	
Required Performance Criteria:	☒ Complied	

Test Data

■ AC 24 V Mode

☒ Input a.c. power ports – Coupling/Decoupling Network used

Mode of Application	Observations	
	(+) Burst (kV)	(-) Burst (kV)
L – N	Complied	Complied

☐ Input d.c. power ports – Coupling/Decoupling Network used

Mode of Application	Observations	
	(+) Burst (kV)	(-) Burst (kV)
-	-	-

☒ Signal ports and telecommunication ports – Coupling Clamp used

Mode of Application	Observations	
	(+) Burst (kV)	(-) Burst (kV)
RJ-45	Complied	Complied
Controller (4 Pin)	Complied	Complied
Alarm (2 Pin)	Complied	Complied

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■ PoE Mode☐ Input a.c. power ports – Coupling/Decoupling Network used

Mode of Application	Observations	
	(+) Burst (kV)	(-) Burst (kV)
-	-	-

☐ Input d.c. power ports – Coupling/Decoupling Network used

Mode of Application	Observations	
	(+) Burst (kV)	(-) Burst (kV)
-	-	-

☒ Signal ports and telecommunication ports – Coupling Clamp used

Mode of Application	Observations	
	(+) Burst (kV)	(-) Burst (kV)
RJ-45	Complied	Complied
Controller (4 Pin)	Complied	Complied
Alarm (2 Pin)	Complied	Complied

Note: "Blank" = Not performed

Observations:

Complied – No degradation of function

Test Results

- ☒ PASS Required Performance Criteria
☐ NOT PASS Required Performance Criteria

RemarksPASS Required Performance Criteria.



3.4 Surge Transients

Reference Standard

EN 61000-4-5:2014

Test Date

Dec. 13, 2017

Test Location

EMS-Surge: Electro wave Shieldroom

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMS Test S/W	iec.control	AMETEK CTS	7.1.2	-
☒	ULTRA COMPACT SIMULATOR	UCS 500 N5	EM TEST	V0936105120	10, 16, 2018
☒	MOTOR VARIAC	MV2616	EM TEST	V0936105123	06, 26, 2018
☒	CDN	CNV 508N1	EM TEST	P1551168979	04, 26, 2018
☐	CDN	CNV 508T5	EM TEST	P1549168422	04, 26, 2018

Test Conditions

Temperature: 21,9 °C
Relative Humidity: 46,2 % R.H.
Atmospheric Pressure: 100,9 kPa



Test Specifications

AC Power Lines

Source Impedance: 12 ohm for common Mode and 2 ohm for differential Mode

Surge Amplitude :

Common Mode

☐ (0,5 / 1,0 / 2,0) kV

Differential Mode

☒ (0,5 / 1,0) kV

Number of Surges:

☒ 5 surges per angle

Angle:

☒ 0°, 90°, 180°, 270° (input a.c. power port)

Polarity:

☒ Positive & Negative

Repetition Rate:

☒ 1 surge per min ☐ 1 surge per 30 sec.

Required Performance Criteria: ☒ Complied

Other supply / Signal Lines

Source Impedance: 42 ohm for common Mode

Surge Amplitude:

Common Mode

☒ (0,5 / 1,0) kV

Number of Surges:

☒ 5 Surges

Polarity:

☒ Positive & Negative

Repetition Rate:

☒ 1 surge per min ☐ 1 surge per 30 sec.

Required Performance Criteria: ☒ Complied

Test Data

■ AC 24 V Mode

☒ Line to Line – Differential Mode

Mode of Application	Observations	
	(+) Surge (kV)	(-) Surge (kV)
L - N	Complied	Complied

Signal Lines

☒ Line to Earth – Common Mode

Mode of Application	Observations	
	(+) Surge (kV)	(-) Surge (kV)
RJ-45	Complied	Complied
Alarm (2 Pin)	Complied	Complied
Controller (4 Pin)	Complied	Complied

■ PoE Mode

☐ Line to Earth – Common Mode

Mode of Application	Observations	
	(+) Surge (kV)	(-) Surge (kV)
-	-	-

Signal Lines

☒ Line to Earth – Common Mode

Mode of Application	Observations	
	(+) Surge (kV)	(-) Surge (kV)
RJ-45	Complied	Complied
Alarm (2 Pin)	Complied	Complied
Controller (4 Pin)	Complied	Complied

Note: "Blank" = Not performed

Observations:

Complied – No degradation of function

Test Results

☒ PASS Required Performance Criteria

☐ NOT PASS Required Performance Criteria

Remarks

PASS Required Performance Criteria.

3.5 Conducted Disturbance

Reference Standard

EN 61000-4-6:2014

Test Date

Dec. 12, 2017

Test Location

EMS-CS: Electro wave Shieldroom

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMS Test S/W	icd.control	EM TEST	5.3.11	-
☒	CONTINUOUS WAVE SIMULATOR	CWS 500N1.4	EM TEST	P1602169880	11, 27, 2018
☒	ATTENUATOR	ATT 6/80	EM TEST	P1614178148	11, 27, 2018
☒	CDN	CDN M016	TESEQ	43694	11, 27, 2018
☐	CDN	CDN M016	TESEQ	43697	11, 27, 2018
☒	CDN	CDN T800	TESEQ	42800	11, 27, 2018
☒	EM CLAMP	KEMZ 801A	TESEQ	44099	11, 28, 2018

Test Conditions

Temperature: 20,1 °C
Relative Humidity: 42,1 % R.H.
Atmospheric Pressure: 101,6 kPa

Test Specifications

Frequency range: ☒ 150 kHz to 100 MHz ☐ 150 kHz to 80 MHz

Voltage Level: ☐ 1 Vrms ☐ 3 Vrms
☒ 10 Vrms

Modulation: ☒ AM, 80 %, 1 kHz sine wave
☒ PM, 1 Hz (0,5 s ON : 0,5 s OFF)

Frequency step: ☒ 1 % step

Dwell Time: ☒ 1 s ☐ 3 s

Required Performance Criteria: ☒ Complied

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The results shown in this test report refer only to the sample(s) tested unless otherwise stated.



Test Data

■ AC 24 V Mode

☒ Input a.c. power ports

Coupling Location (Line Stressed)	Coupling Method	Observations
L – N	CDN (☒ M2, ☐ M3)	Complied

☐ Input d.c. power ports

Coupling Location (Line Stressed)	Coupling Method	Observations
-	CDN (☐ M2, ☐ M3)	-

☒ Signal ports and telecommunication ports

Coupling Location (Line Stressed)	Coupling Method	Observations
RJ-45	CDN T800	Complied
Alarm (2 Pin)	EM Injection Clamp	Complied
Controller (4 Pin)	EM Injection Clamp	Complied

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■ PoE Mode☐ Input a.c. power ports

Coupling Location (Line Stressed)	Coupling Method	Observations
-	CDN (☐ M2, ☐ M3)	-

☐ Input d.c. power ports

Coupling Location (Line Stressed)	Coupling Method	Observations
-	CDN (☐ M2, ☐ M3)	-

☒ Signal ports and telecommunication ports

Coupling Location (Line Stressed)	Coupling Method	Observations
RJ-45	CDN T800	Complied
Alarm (2 Pin)	EM Injection Clamp	Complied
Controller (4 Pin)	EM Injection Clamp	Complied

Notes: CDN = Coupling Decoupling Network
"blank" = Not performed

Observations:

Complied – No degradation of function

Test Results

- ☒ PASS Required Performance Criteria
☐ NOT PASS Required Performance Criteria

Remarks

PASS Required Performance Criteria.



3.6 Voltage Dips and Short Interruptions

Reference Standard

EN 61000-4-11:2004

Test Date

Dec. 13, 2017

Test Location

EMS-Voltage dip: Electro wave Shieldroom

Test Equipment

Used	Description	Model Number	Manufacturer	Serial Number	Cal. Due
☒	EMS Test S/W	iec.control	AMETEK CTS	7.1.2	-
☒	ULTRA COMPACT SIMULATOR	UCS 500 N5	EM TEST	V0936105120	06, 26, 2018
☒	MOTOR VARIAC	MV2616	EM TEST	V0936105123	06, 26, 2018

Test Conditions

Temperature: 21,9 °C
Relative Humidity: 46,2 % R.H.
Atmospheric Pressure: 100,9 kPa



Test Specifications & Observations/Remarks

■ AC 24 V Mode (Test Voltage : 230 V)

<u>Test Level</u>	<u>Duration [in period/ms (50 Hz)]</u>	<u>Results</u>
☒ 20 % dip	☒ 250 / 5 000	<u>Complied</u>
☒ 30 % dip	☒ 25 / 500	<u>Complied</u>
☒ 60 % dip	☒ 10 / 200	<u>Complied</u>
☒ 100 % dip	☒ 250 / 5 000	<u>Complied</u>

- Voltage variations

☒ Unom + 10 %	☒ 253.0 V (ac)	<u>Complied</u>
☒ Unom - 15 %	☒ 195.5 V (ac)	<u>Complied</u>

Observations:
Complied – No degradation of function

Test Results

- ☒ PASS Required Performance Criteria
☐ NOT PASS Required Performance Criteria
☐ NOT APPLICABLE

Remarks

PASS Required Performance Criteria.

*The test has been tested using the AC / AC Adaptor

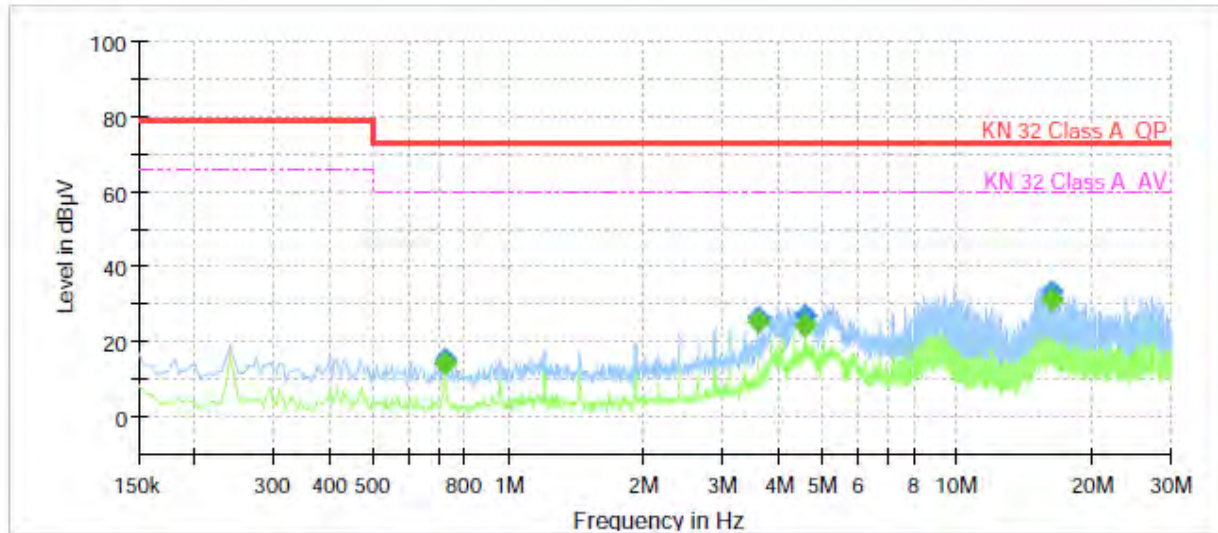
APPENDIX A – TEST DATA

Conducted Emissions at Mains Power Ports

■ AC 24 V Mode
[HOT]

Common Information

Test Description:	Conducted Emission
Model No.:	SNP-6320P
Mode	H
Operator Name:	KES



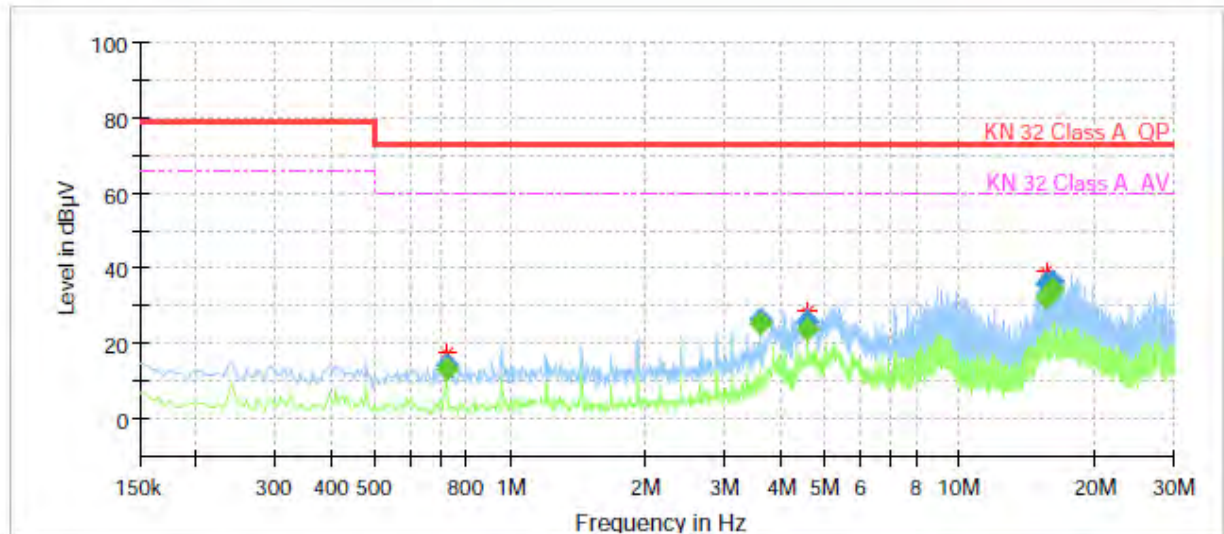
Final Result

Frequency (MHz)	QuasiPeak (dBμV)	CAverage (dBμV)	Limit (dBμV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Corr. (dB)
0.720000	---	14.44	60.00	45.56	1000.0	9.000	L1	19.9
0.720000	15.43	---	73.00	57.57	1000.0	9.000	L1	19.9
3.605000	---	25.51	60.00	34.49	1000.0	9.000	L1	20.0
3.605000	26.44	---	73.00	46.56	1000.0	9.000	L1	20.0
4.570000	---	24.14	60.00	35.86	1000.0	9.000	L1	19.8
4.570000	27.22	---	73.00	45.78	1000.0	9.000	L1	19.8
16.225000	---	31.45	60.00	28.55	1000.0	9.000	L1	20.1
16.225000	33.45	---	73.00	39.55	1000.0	9.000	L1	20.1

[NEUTRAL]

Common Information

Test Description: Conducted Emission
Model No.: SNP-6320P
Mode: N
Operator Name: KES



Final Result

Frequency (MHz)	QuasiPeak (dBμV)	CAverage (dBμV)	Limit (dBμV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Corr. (dB)
0.720000	---	13.04	60.00	46.96	1000.0	9.000	N	19.9
0.720000	14.37	---	73.00	58.63	1000.0	9.000	N	19.9
3.605000	---	25.54	60.00	34.46	1000.0	9.000	N	20.0
3.605000	26.45	---	73.00	46.55	1000.0	9.000	N	20.0
4.565000	---	23.63	60.00	36.37	1000.0	9.000	N	19.8
4.565000	26.11	---	73.00	46.89	1000.0	9.000	N	19.8
15.660000	---	32.43	60.00	27.57	1000.0	9.000	N	20.2
15.660000	36.02	---	73.00	36.98	1000.0	9.000	N	20.2
16.165000	---	34.24	60.00	25.76	1000.0	9.000	N	20.2
16.165000	36.62	---	73.00	36.38	1000.0	9.000	N	20.2

◆ Calculation

QuasiPeak[dBμV] / CAverage [dBμV] = Reading Value[dBμV] + Corr. [dB]

QuasiPeak / CAverage : The Final Value

Reading Value : Not shown in the table.

Corr. : Correction values (LISN FACTOR + (Cable Loss + Pulse Limiter FACTOR))

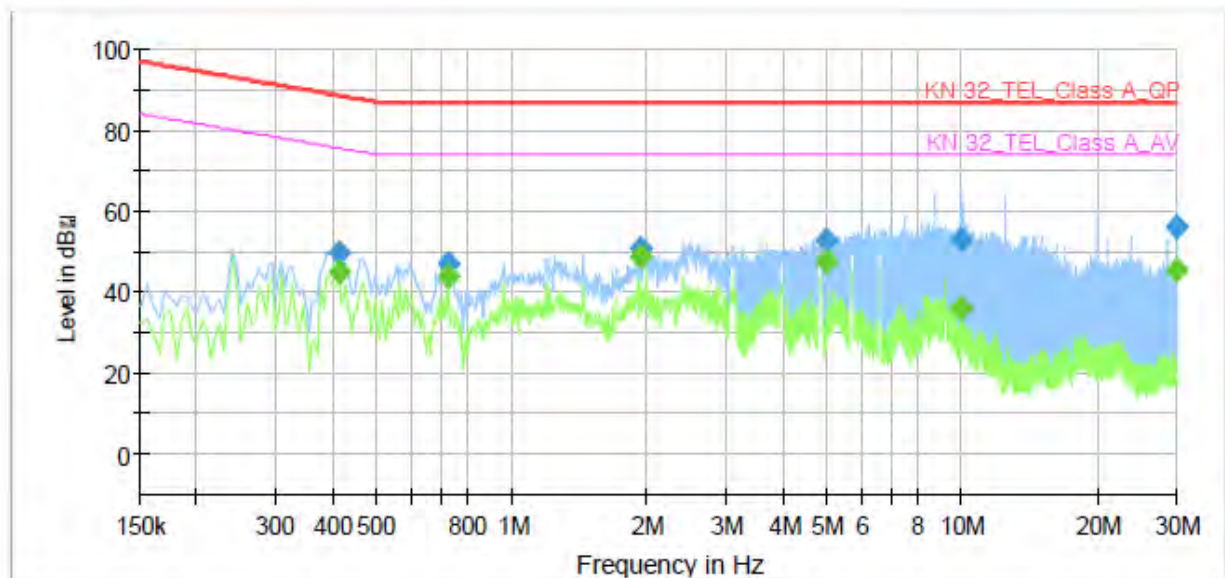
Conducted Emissions at Telecommunication Ports

■ AC 24 V mode

[10 Mbps]

Common Information

Test Description:	Telecommunication Emission
Model No.:	SNP-6320P
Mode	AC 24V 10 Mbps
Operator Name:	KES



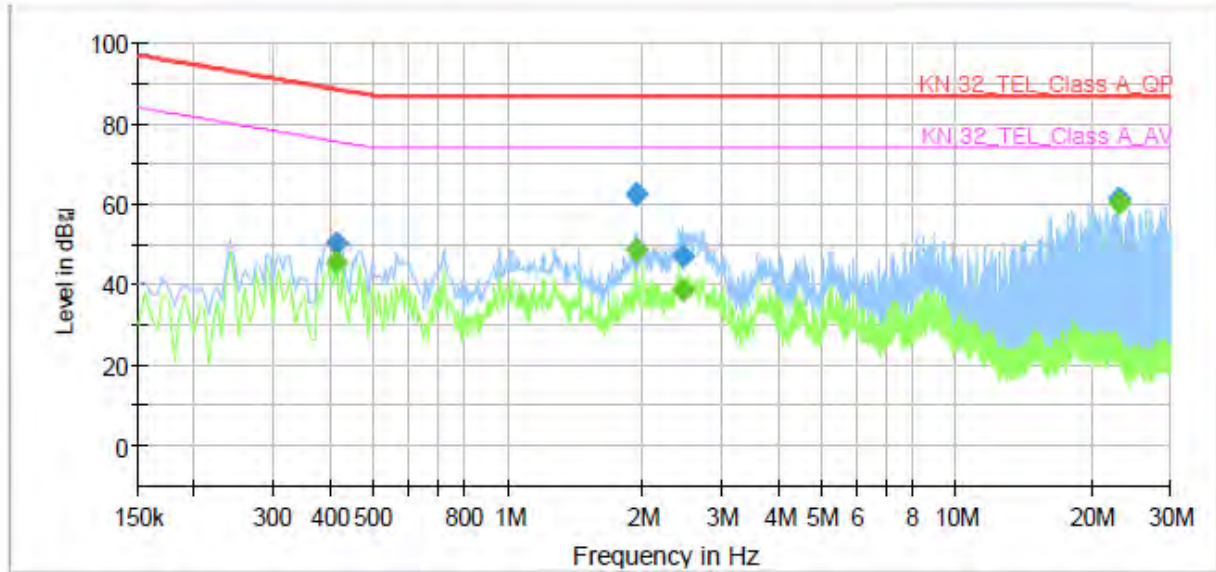
Final Result

Frequency (MHz)	QuasiPeak (dBμV)	CAverage (dBμV)	Limit (dBμV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Corr. (dB)
0.415000	---	44.97	75.55	30.58	1000.0	9.000	Single Line	19.6
0.415000	49.99	---	88.55	38.56	1000.0	9.000	Single Line	19.6
0.720000	---	43.69	74.00	30.31	1000.0	9.000	Single Line	19.8
0.720000	47.30	---	87.00	39.70	1000.0	9.000	Single Line	19.8
1.925000	---	48.53	74.00	25.47	1000.0	9.000	Single Line	20.0
1.925000	50.79	---	87.00	36.21	1000.0	9.000	Single Line	20.0
5.000000	---	47.52	74.00	26.48	1000.0	9.000	Single Line	19.5
5.000000	52.90	---	87.00	34.10	1000.0	9.000	Single Line	19.5
9.990000	---	35.83	74.00	38.17	1000.0	9.000	Single Line	19.8
9.990000	52.75	---	87.00	34.25	1000.0	9.000	Single Line	19.8
29.995000	---	45.43	74.00	28.57	1000.0	9.000	Single Line	20.8
29.995000	55.92	---	87.00	31.08	1000.0	9.000	Single Line	20.8

[100 Mbps]

Common Information

Test Description:	Telecommunication Emission
Model No.:	SNP-6320P
Mode	AC24V 100 Mbps
Operator Name:	KES



Final Result

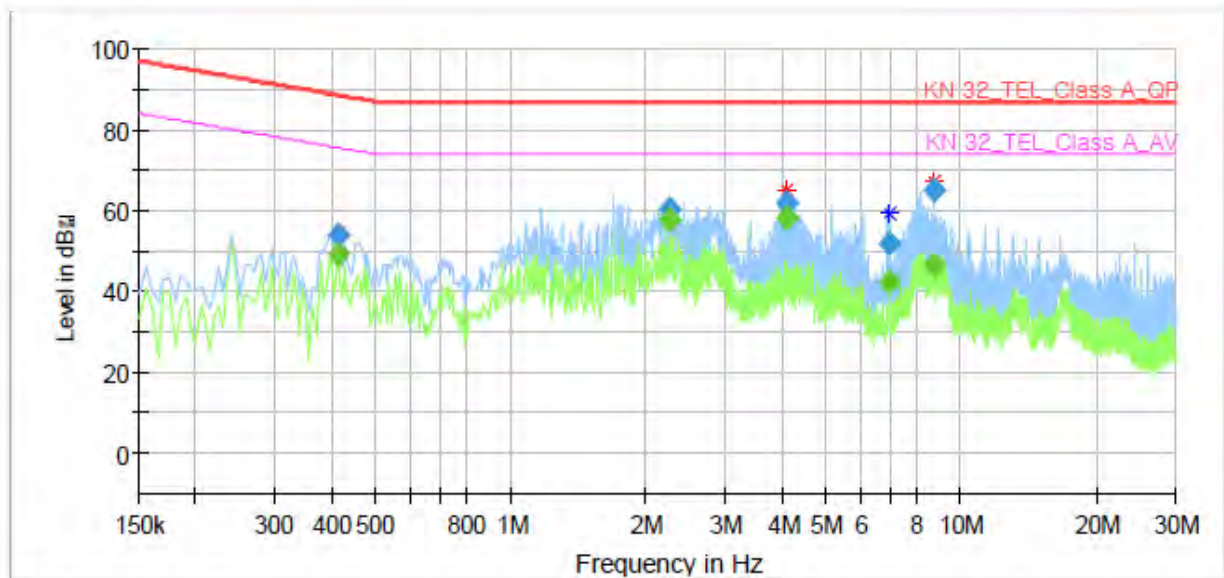
Frequency (MHz)	QuasiPeak (dBμV)	CAverage (dBμV)	Limit (dBμV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Corr. (dB)
0.415000	---	45.54	75.55	30.01	1000.0	9.000	Single Line	19.9
0.415000	50.50	---	88.55	38.05	1000.0	9.000	Single Line	19.9
1.925000	---	48.94	74.00	25.06	1000.0	9.000	Single Line	20.3
1.925000	62.55	---	87.00	24.45	1000.0	9.000	Single Line	20.3
2.450000	---	38.51	74.00	35.49	1000.0	9.000	Single Line	20.2
2.450000	47.01	---	87.00	39.99	1000.0	9.000	Single Line	20.2
23.130000	---	60.15	74.00	13.85	1000.0	9.000	Single Line	20.6
23.130000	61.61	---	87.00	25.39	1000.0	9.000	Single Line	20.6

■ PoE mode

[10 Mbps]

Common Information

Test Description:	Telecommunication Emission
Model No.:	SNP-6320P
Mode	PoE 10 Mbps
Operator Name:	KES



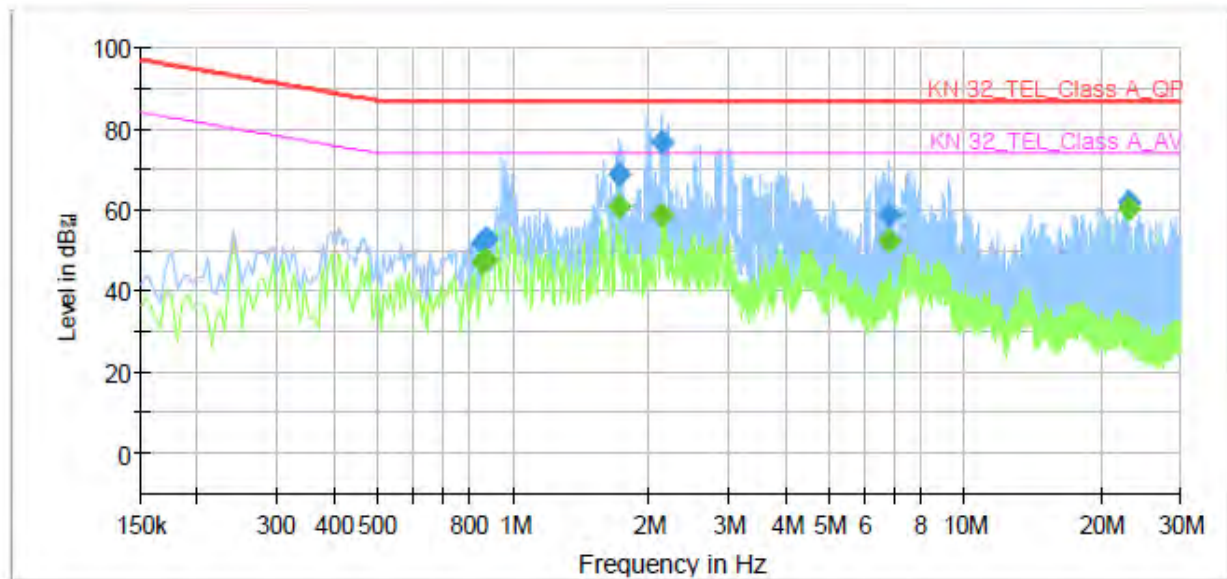
Final Result

Frequency (MHz)	QuasiPeak (dBμV)	CAverage (dBμV)	Limit (dBμV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Corr. (dB)
0.415000	---	48.99	75.55	26.56	1000.0	9.000	Single Line	19.6
0.415000	53.76	---	88.55	34.79	1000.0	9.000	Single Line	19.6
2.255000	---	57.84	74.00	16.16	1000.0	9.000	Single Line	20.0
2.255000	60.27	---	87.00	26.73	1000.0	9.000	Single Line	20.0
4.120000	---	58.26	74.00	15.74	1000.0	9.000	Single Line	19.6
4.120000	62.02	---	87.00	24.98	1000.0	9.000	Single Line	19.6
6.905000	---	42.26	74.00	31.74	1000.0	9.000	Single Line	19.4
6.905000	51.84	---	87.00	35.16	1000.0	9.000	Single Line	19.4
8.750000	---	46.85	74.00	27.15	1000.0	9.000	Single Line	19.6
8.750000	65.07	---	87.00	21.93	1000.0	9.000	Single Line	19.6

[100 Mbps]

Common Information

Test Description:	Telecommunication Emission
Model No.:	SNP-6320P
Mode	PoE 100 Mbps
Operator Name:	KES



Final Result

Frequency (MHz)	QuasiPeak (dBμV)	CAverage (dBμV)	Limit (dBμV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Corr. (dB)
0.855000	---	46.98	74.00	27.02	1000.0	9.000	Single Line	20.2
0.855000	52.10	---	87.00	34.90	1000.0	9.000	Single Line	20.2
0.875000	---	47.74	74.00	26.26	1000.0	9.000	Single Line	20.2
0.875000	52.74	---	87.00	34.26	1000.0	9.000	Single Line	20.2
1.705000	---	60.65	74.00	13.35	1000.0	9.000	Single Line	20.3
1.705000	68.81	---	87.00	18.19	1000.0	9.000	Single Line	20.3
2.125000	---	58.77	74.00	15.23	1000.0	9.000	Single Line	20.3
2.125000	76.52	---	87.00	10.48	1000.0	9.000	Single Line	20.3
6.815000	---	52.62	74.00	21.38	1000.0	9.000	Single Line	19.7
6.815000	58.88	---	87.00	28.12	1000.0	9.000	Single Line	19.7
23.130000	---	60.11	74.00	13.89	1000.0	9.000	Single Line	20.6
23.130000	62.01	---	87.00	24.99	1000.0	9.000	Single Line	20.6



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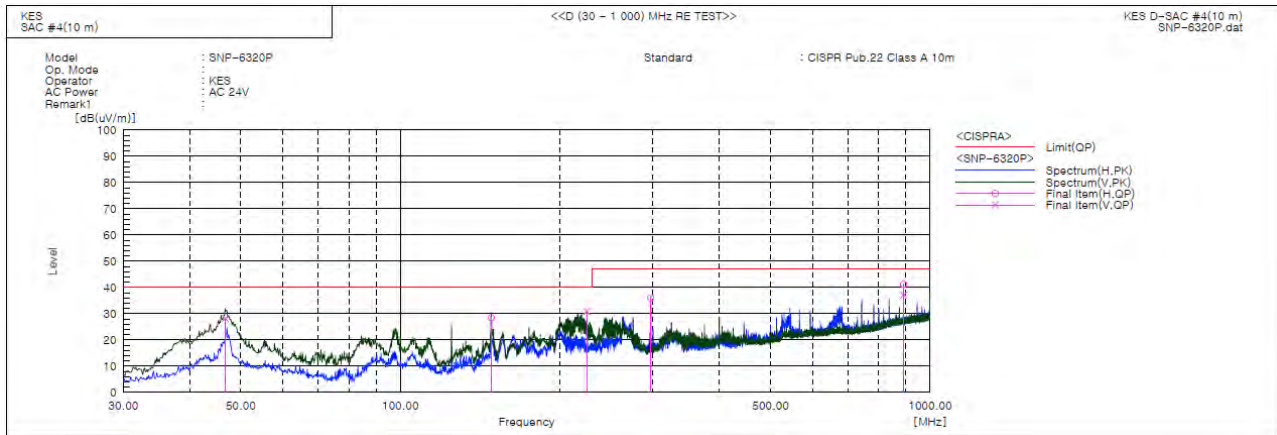
Test report No.:

KES-E1-17T0828

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Radiated Electric Field Emissions(Below 1 GHz)

■ AC 24 V Mode



Final Result

No.	Frequency [MHz]	(P)	Reading QP [dB(uV)]	c.f [dB(1/m)]	Result QP [dB(uV/m)]	Limit QP [dB(uV/m)]	Margin QP [dB]	Height [cm]	Angle [deg]	Remark
1	891.011	H	51.0	-9.8	41.2	47.0	5.8	100.0	223.0	
2	148.461	H	60.0	-31.5	28.5	40.0	11.5	400.0	115.0	
3	296.993	H	60.1	-24.0	36.1	47.0	10.9	400.0	329.0	
4	46.733	V	56.2	-28.0	28.2	40.0	11.8	400.0	252.0	
5	224.970	V	57.1	-26.2	30.9	40.0	9.1	100.0	279.0	
6	890.996	V	46.9	-9.8	37.1	47.0	9.9	150.0	22.0	

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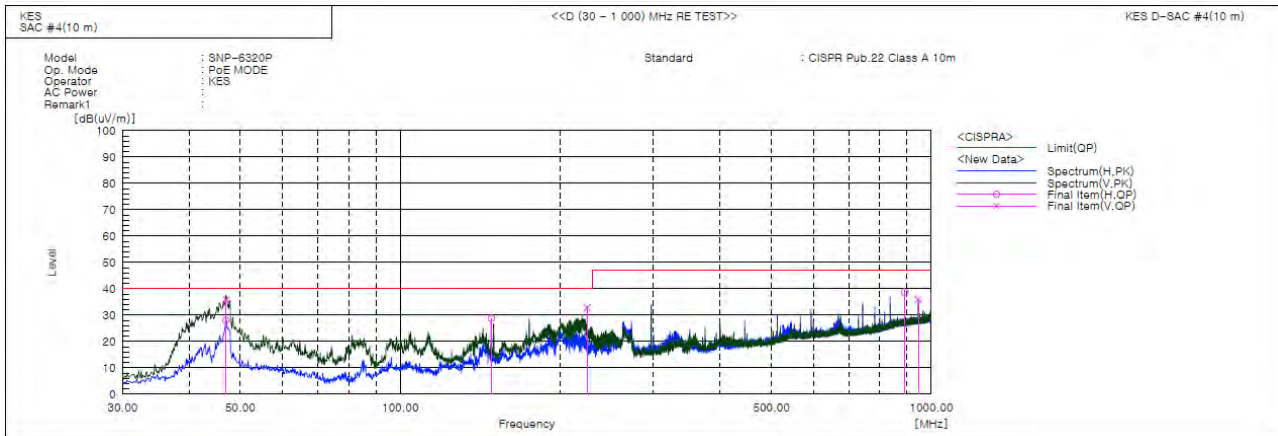


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■ PoE Mode



Final Result

No.	Frequency [MHz]	(P)	Reading QP [dB(uV)]	c.f [dB(1/m)]	Result QP [dB(uV/m)]	Limit QP [dB(uV/m)]	Margin QP [dB]	Height [cm]	Angle [deg]	Remark
1	46.975	H	56.1	-28.0	28.1	40.0	11.9	400.0	212.0	
2	47.031	V	63.7	-28.0	35.7	40.0	4.3	233.0	199.0	
3	148.461	H	60.3	-31.5	28.8	40.0	11.2	400.0	296.0	
4	224.970	V	59.0	-26.2	32.8	40.0	7.2	100.0	283.0	
5	890.996	H	48.6	-9.8	38.8	47.0	8.2	100.0	175.0	
6	945.074	V	45.3	-9.4	35.9	47.0	11.1	150.0	170.0	

◆ Calculation – SEMI ANECHOIC CHAMBER (10 m)

Result(QP) [dB(μ V/m)] = (Reading(QP)[dB(μ V)] + c.f[dB(1/m)])

Margin(QP)[dB] = Limit[dB(μ V/m)] - Result(QP) [dB(μ V/m)]

Reading(QP) : Reading value, Result(QP) : Reading value + Factor value

Limit(QP) : Limit value, c.f : (ANT Factor + Cable Loss - Preamp Factor), Margin: Margin value



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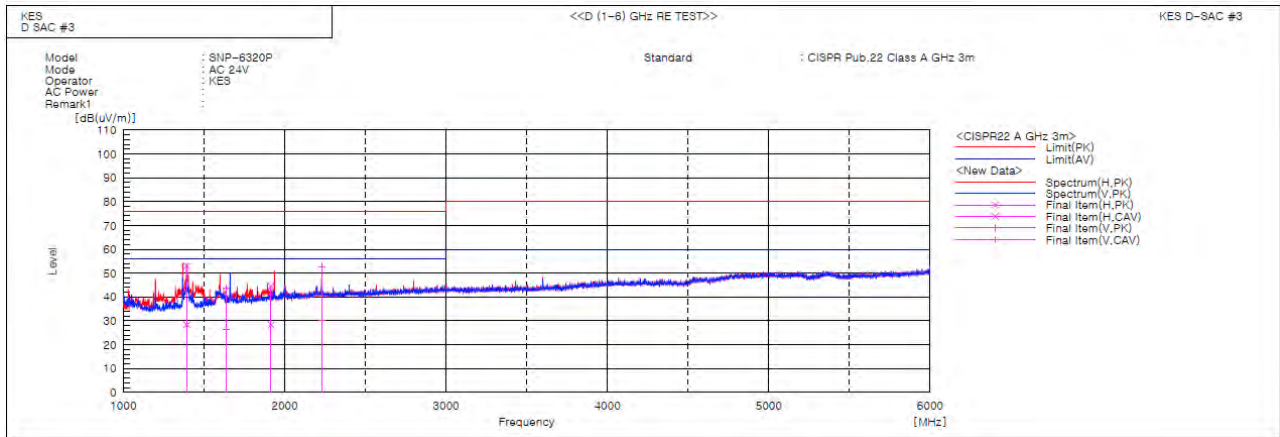
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Radiated Electric Field Emissions(Above 1 GHz)

■ AC 24 V Mode



Final Result

No.	Frequency [MHz]	(P)	Reading PK [dB(uV)]	Reading CAV [dB(uV)]	c.f [dB(1/m)]	Result PK [dB(uV/m)]	Result CAV [dB(uV/m)]	Limit PK [dB(uV/m)]	Limit AV [dB(uV/m)]	Margin PK [dB]	Margin CAV [dB]	Height [cm]	Angle [deg]	Remark
1	1393.295	H	59.9	35.4	-7.0	52.9	28.4	76.0	56.0	23.1	27.6	101.0	49.2	
2	1639.614	V	48.6	31.3	-4.8	43.8	26.5	76.0	56.0	32.2	29.5	101.0	33.6	
3	1915.864	H	46.7	30.6	-2.2	44.5	28.4	76.0	56.0	31.5	27.6	101.0	324.2	
4	2231.920	V	53.3	30.7	-0.5	52.8	30.2	76.0	56.0	23.2	25.8	101.0	39.7	

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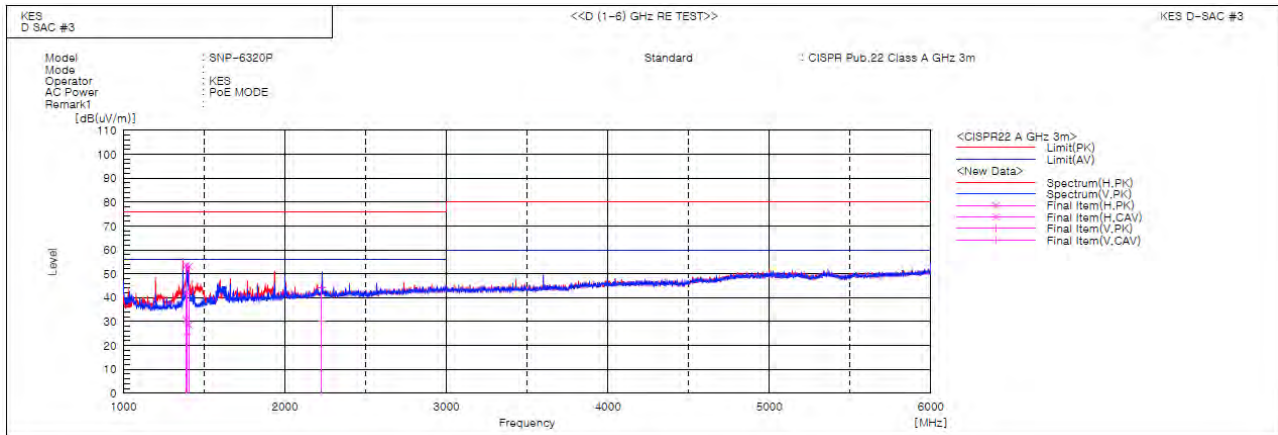


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PoE Mode



Final Result

No.	Frequency [MHz]	(P)	Reading PK [dB(uV)]	Reading CAV [dB(uV)]	c.f [dB(1/m)]	Result PK [dB(uV/m)]	Result CAV [dB(uV/m)]	Limit PK [dB(uV/m)]	Limit AV [dB(uV/m)]	Margin PK [dB]	Margin CAV [dB]	Height [cm]	Angle [deg]	Remark
1	1388.526	H	60.5	37.9	-7.1	53.4	30.8	76.0	56.0	22.6	25.2	101.0	52.8	
2	1392.605	V	48.5	31.9	-7.0	41.5	24.9	76.0	56.0	34.5	31.1	101.0	53.6	
3	1405.768	H	59.9	35.6	-6.9	53.0	28.7	76.0	56.0	23.0	27.3	101.0	59.0	
4	2227.311	V	44.5	30.7	-0.5	44.0	30.2	76.0	56.0	32.0	25.8	101.0	23.9	

◆ Calculation

Over Limit [dB] = (Read Level[dB μ V] + Ant Factor[dB/m] + Cable Loss [dB] – Preamp Factor [dB]) – Limit Line[dB μ V]

Over Limit : Margin, Read Level : Reading value, Ant Factor : ANT Factor,
Cable Loss : Cable loss, Preamp Factor : Preamp Factor



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Test Data - Voltage Fluctuations

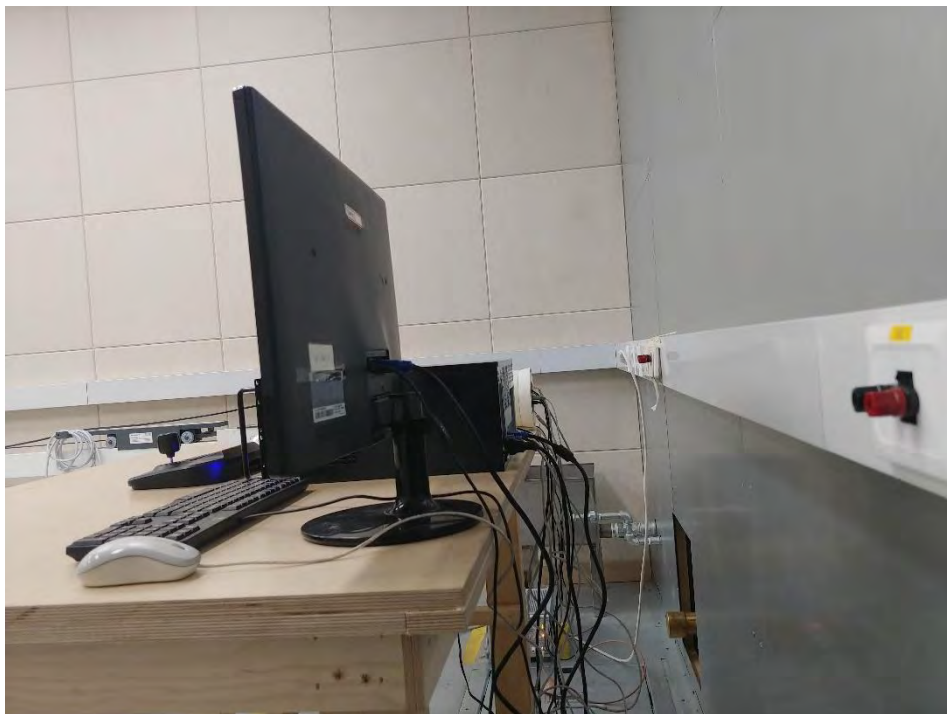
Maximum Flicker results

	EUT values	Limit	Result
Pst	N/A		
Plt			
dc [%]			
dmax [%]			
Tmax [s]			

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Test Setup Photos and Configuration

Conducted Voltage Emissions



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Conducted Telecommunication Emissions



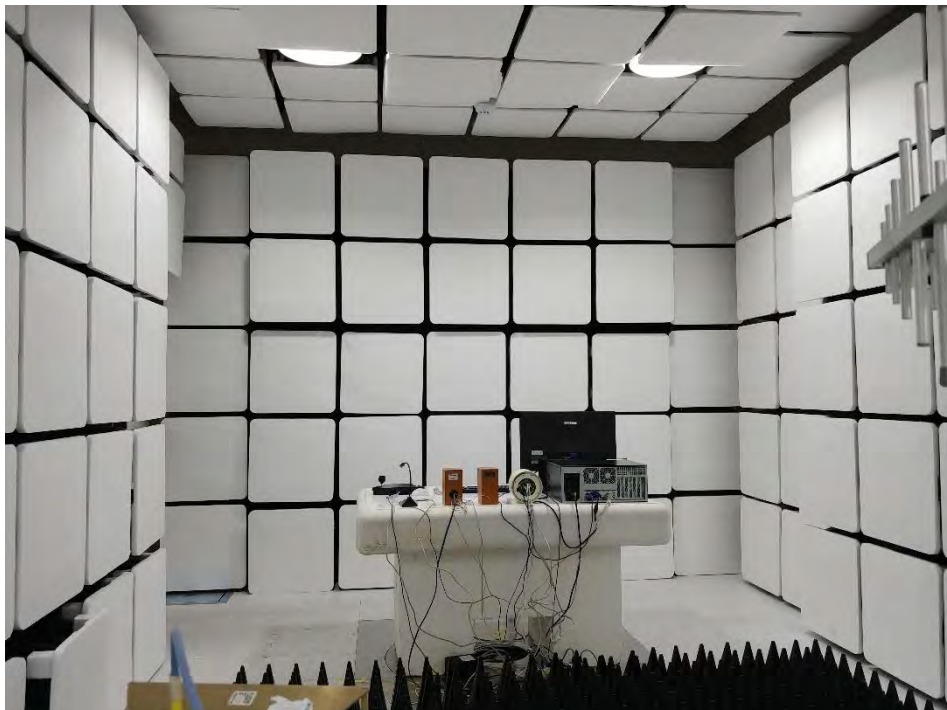
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Radiated Electric Field Emissions(Below 1 GHz)



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Radiated Electric Field Emissions(Above 1 GHz)



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Harmonic Current Emissions and Voltage Fluctuations and Flicker

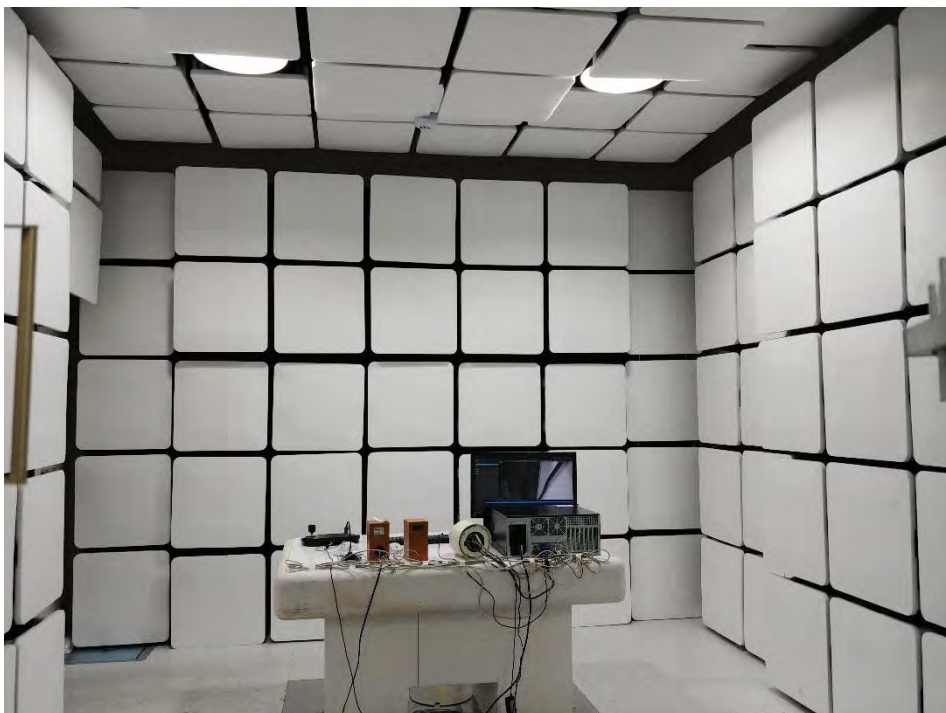
N/A

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Electrostatic Discharge



Radiated Electric Field Immunity



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Electrical Fast Transients/Bursts



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Surge Transients



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Conducted Disturbance



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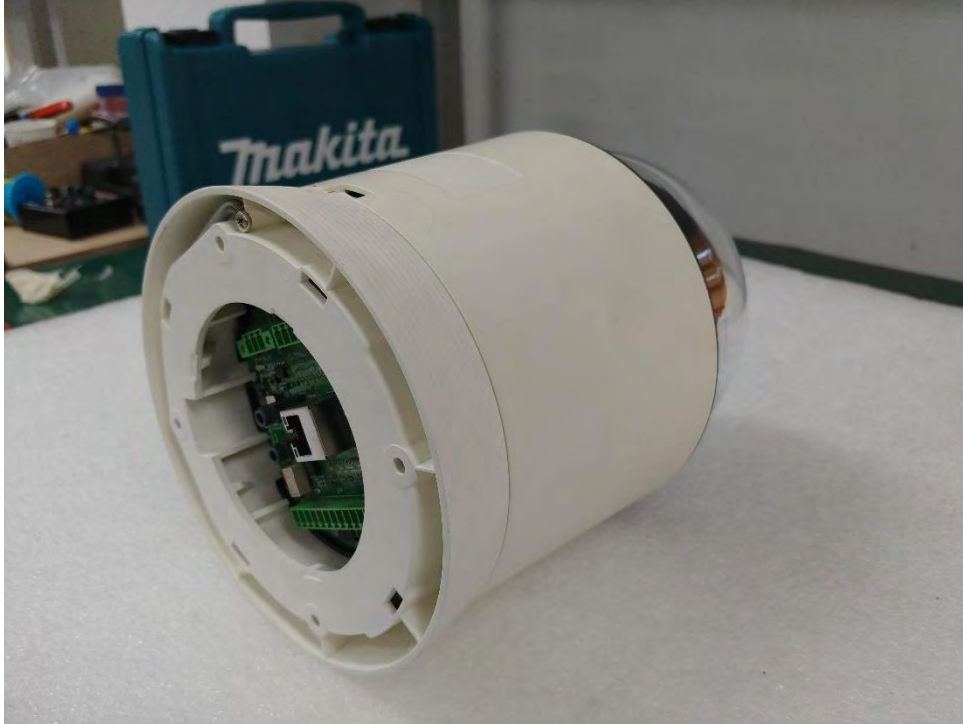
Voltage Dips and Short Interruptions



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EUT External Photographs

(Top)



(Bottom)



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EUT Internal Photographs

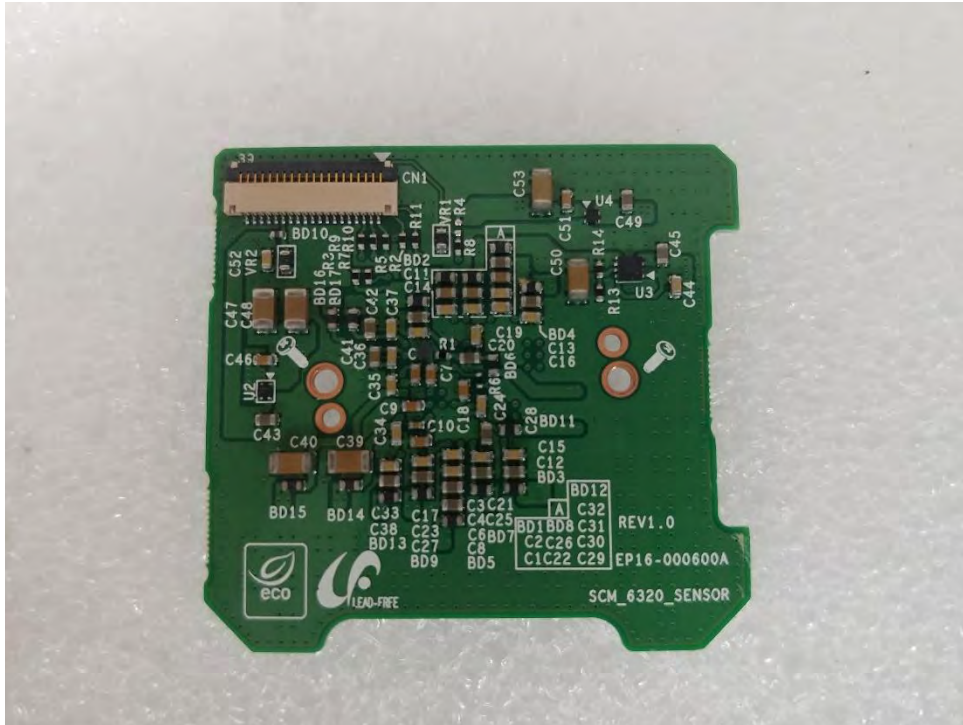
(Internal View)



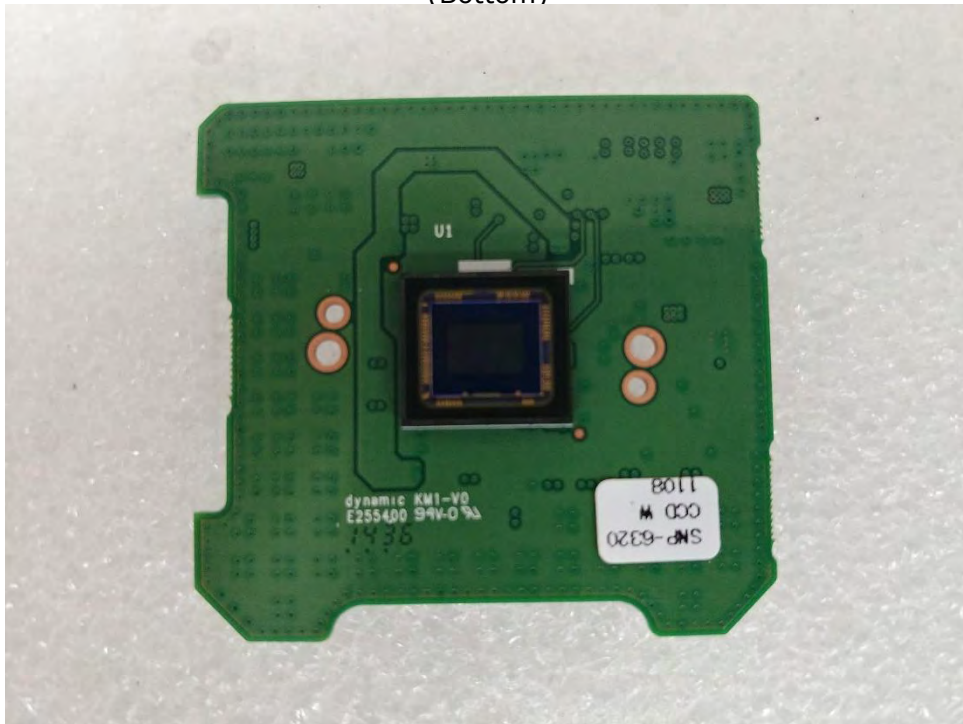
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EUT Internal View – Lens board 1

(Top)



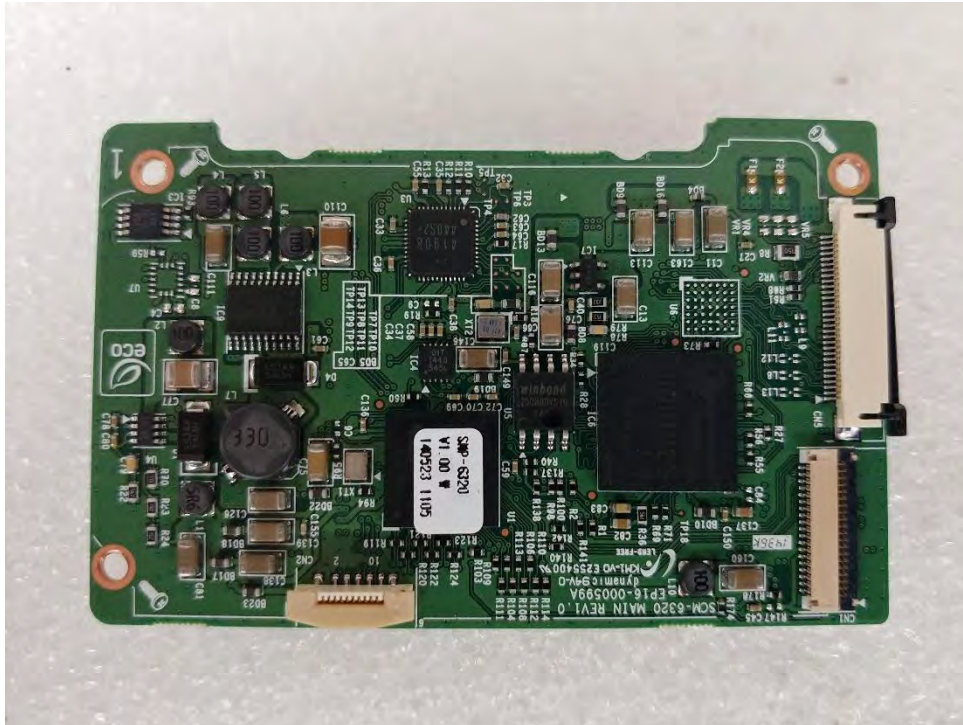
(Bottom)



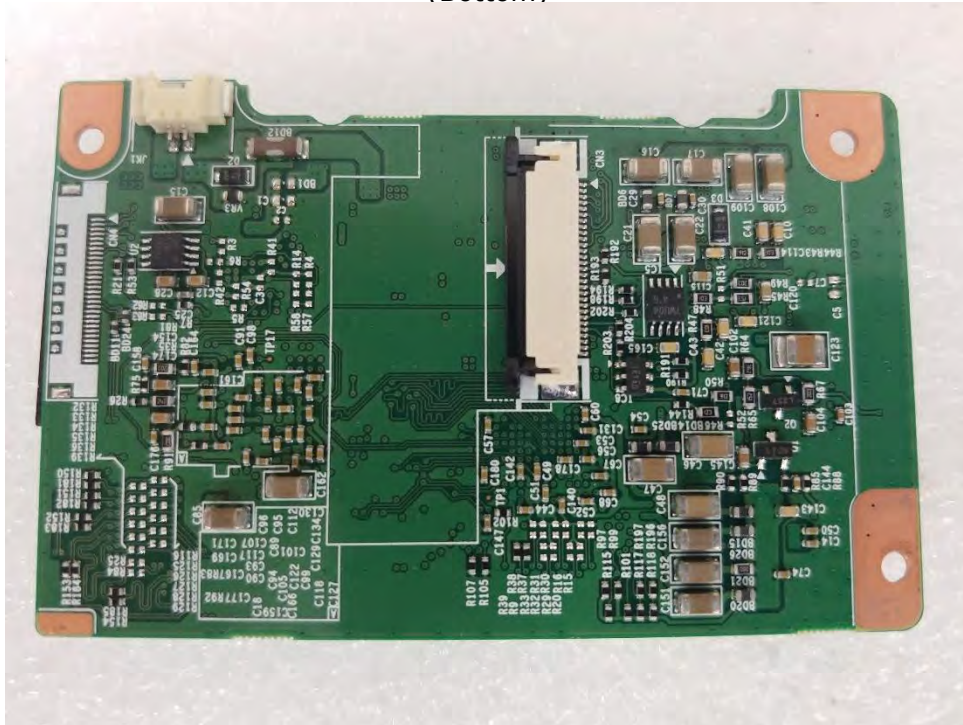
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EUT Internal View – Lens board 2

(Top)



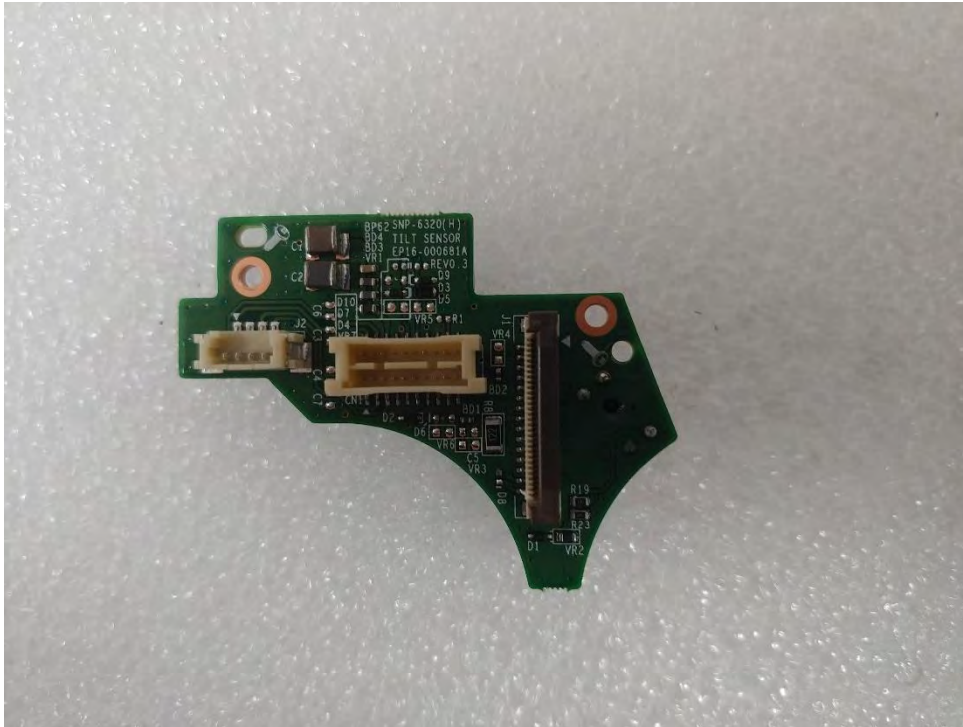
(Bottom)



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EUT Internal View – Lens board 3

(Top)



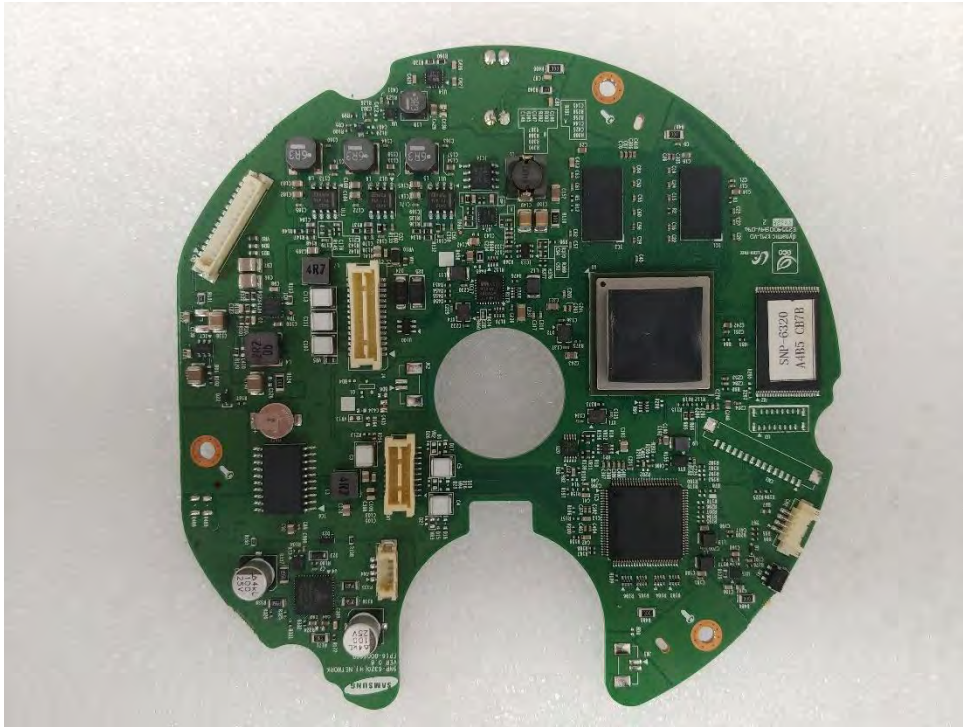
(Bottom)



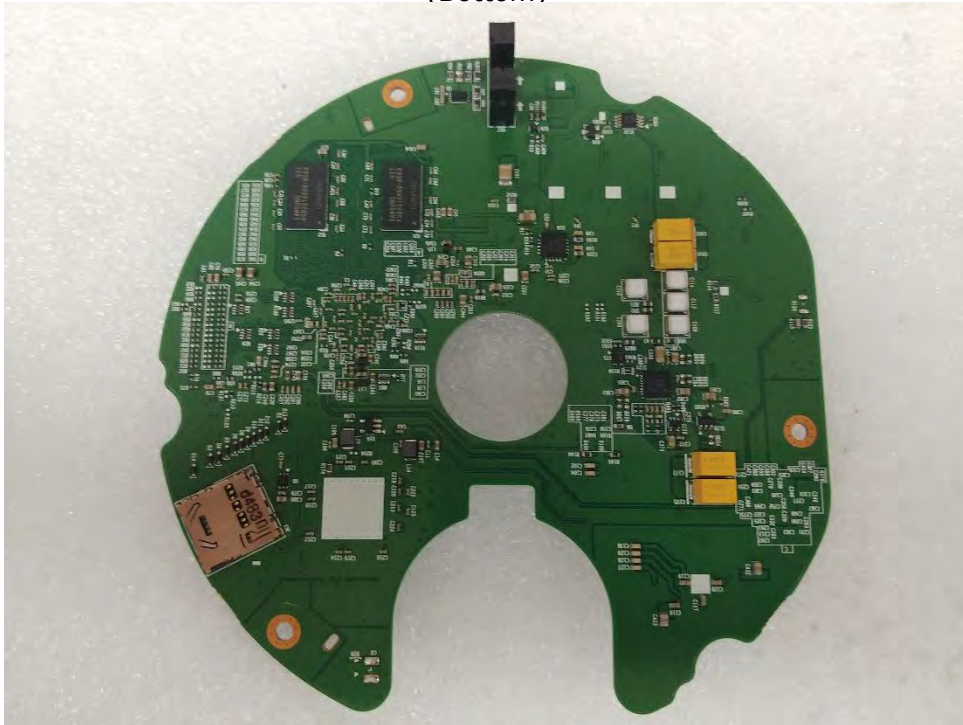
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EUT Internal View – board 1

(Top)



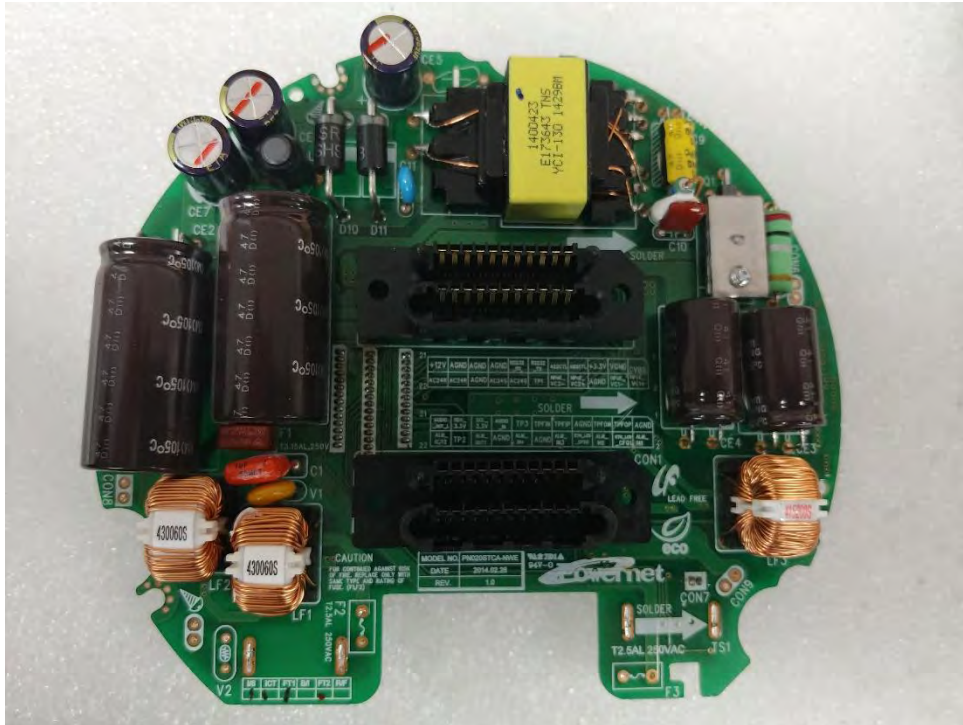
(Bottom)



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EUT Internal View – board 2

(Top)



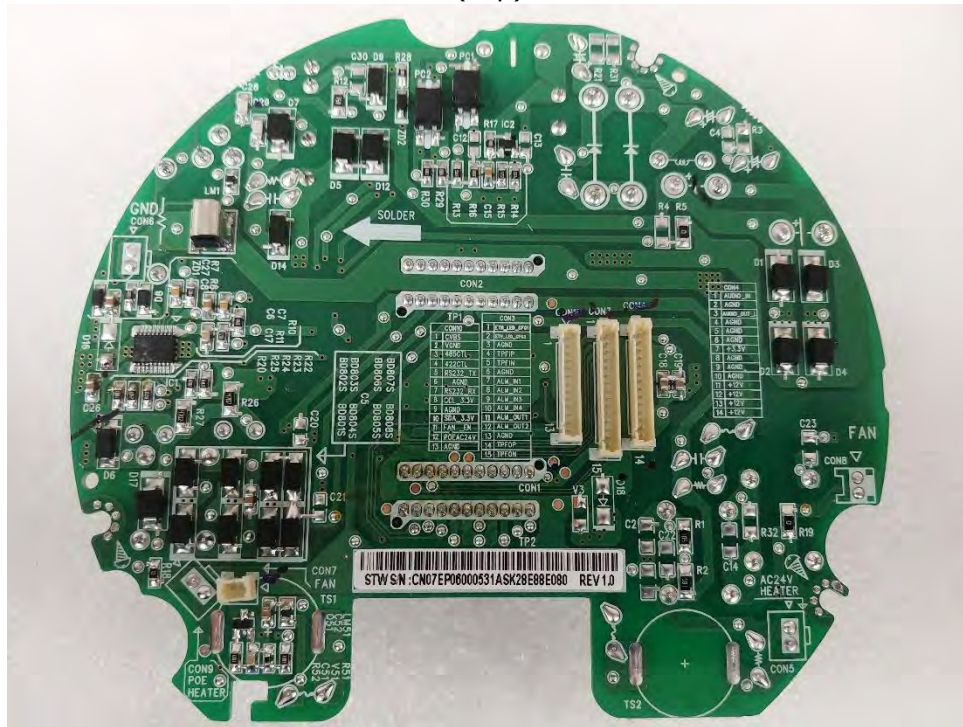
(Bottom)



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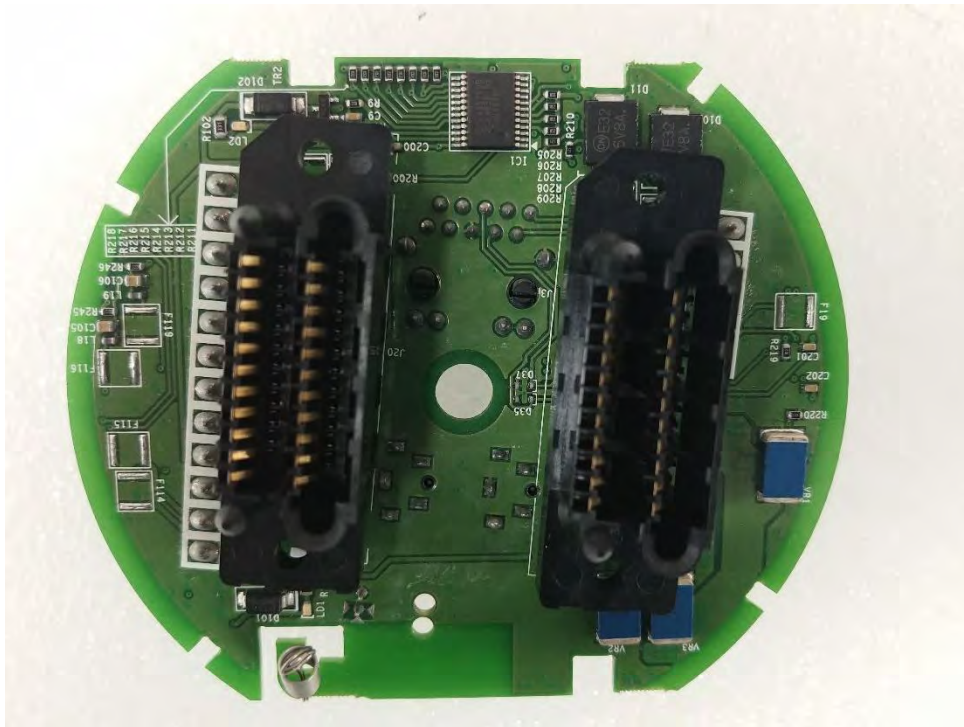
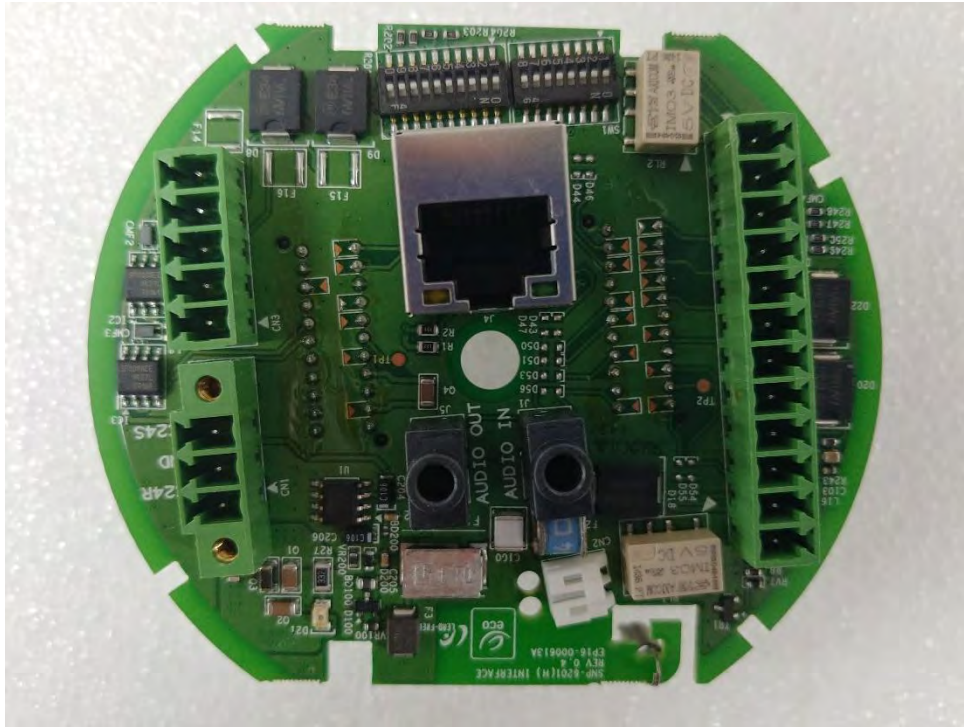
EUT Internal View – board 3

(Top)



EUT Internal View – board 4

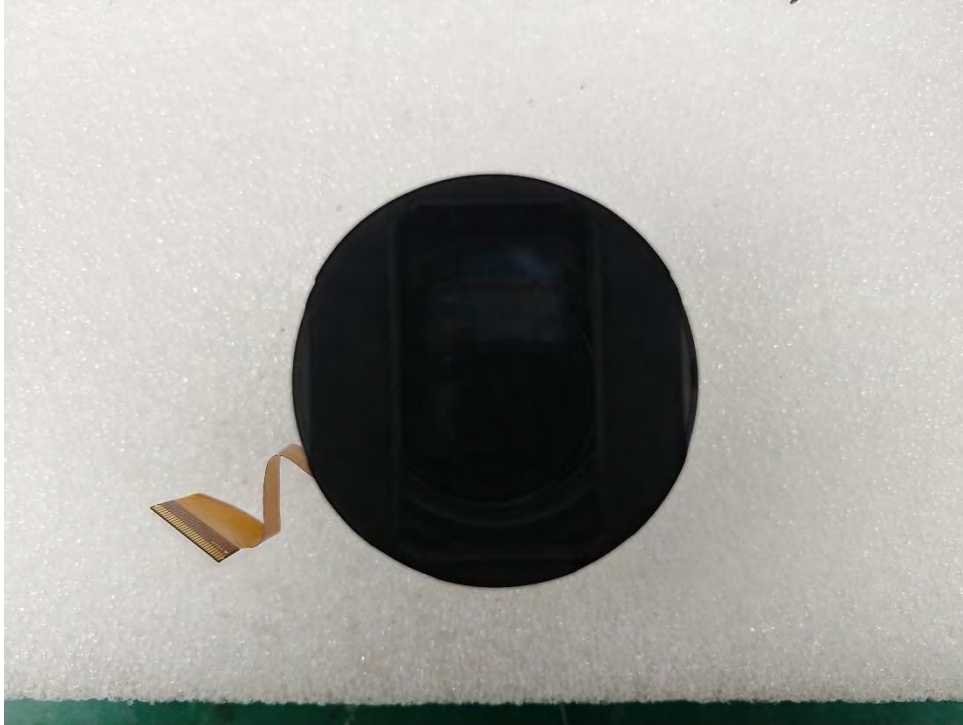
(Top)



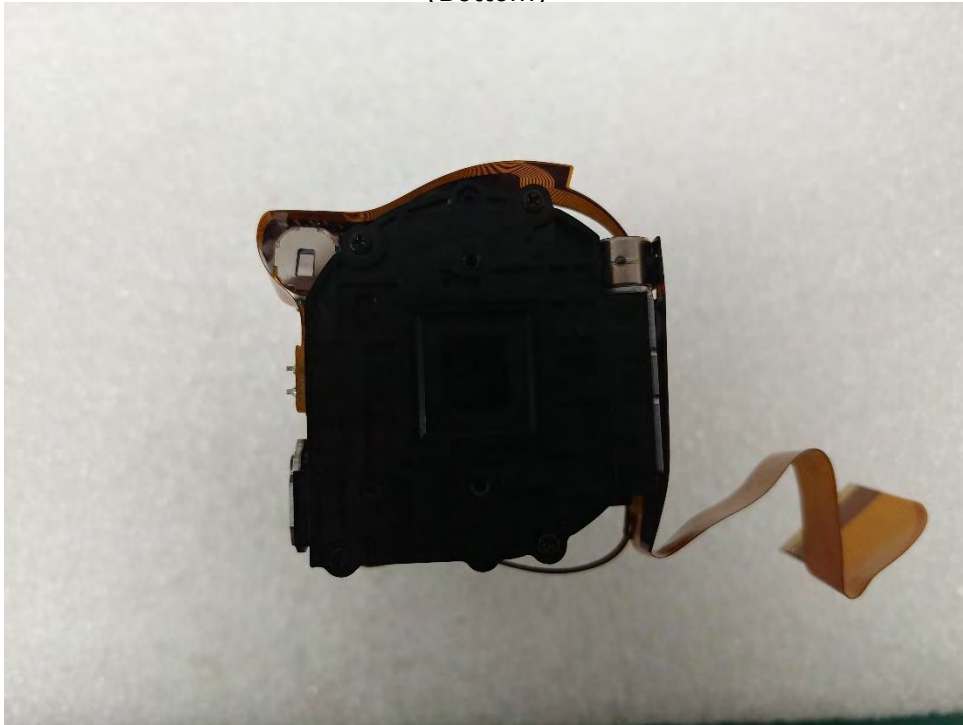
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EUT Internal View – Lens

(Top)



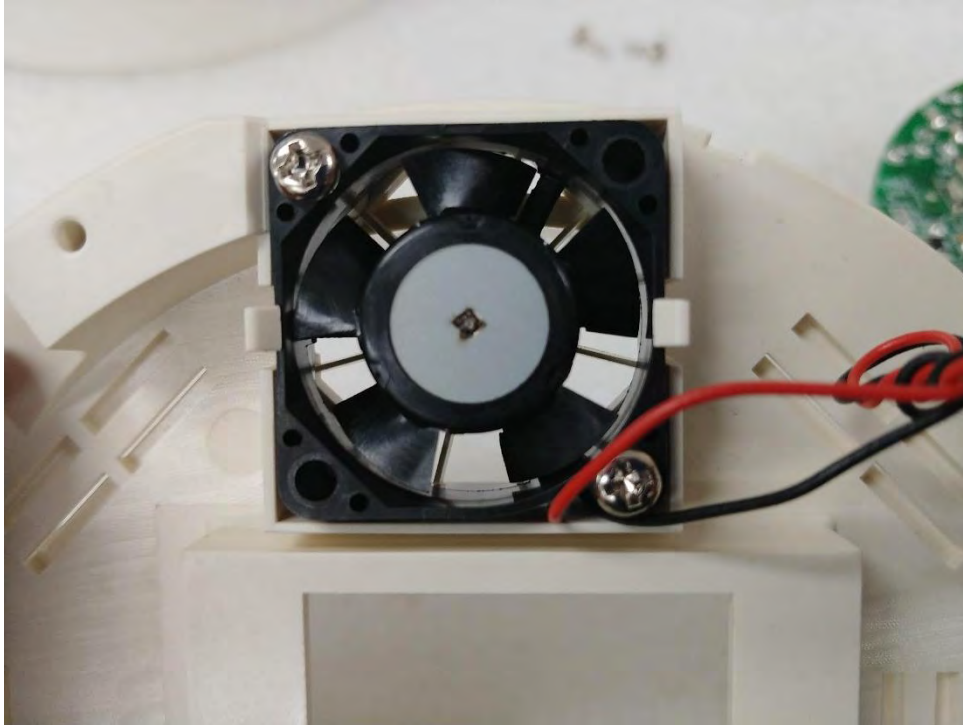
(Bottom)



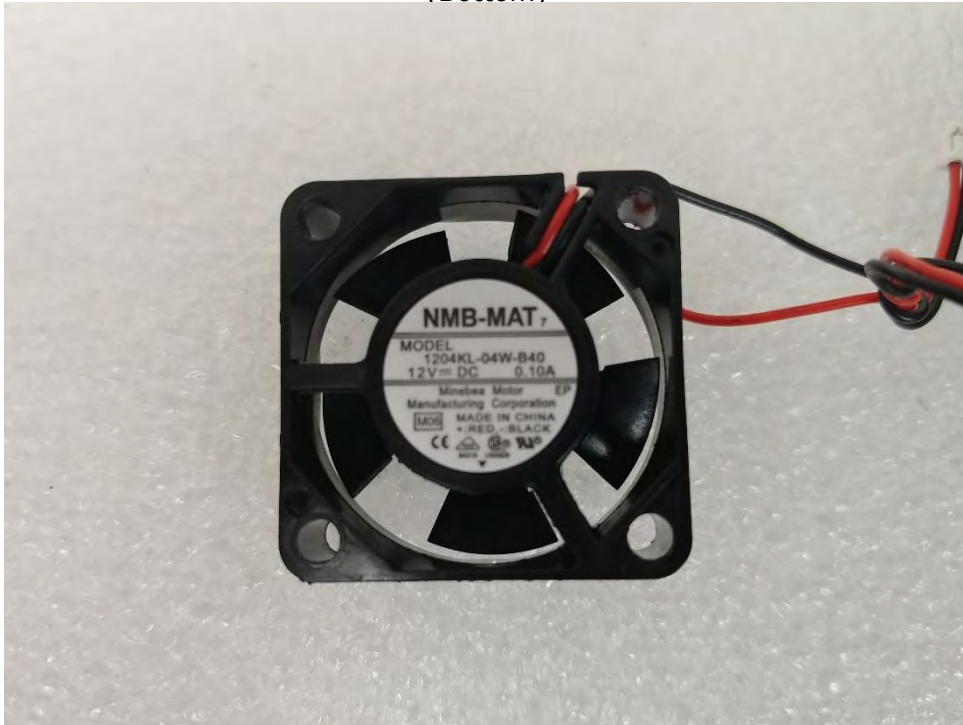
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EUT Internal View – COOLER

(Top)



(Bottom)



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Label and Location



Network Camera

Model No : SNP-6320P

Manufacturer : Hanwha Techwin (Tianjin) Co.,Ltd.

Made in China

